# Old Company Name in Catalogs and Other Documents

On April 1<sup>st</sup>, 2010, NEC Electronics Corporation merged with Renesas Technology Corporation, and Renesas Electronics Corporation took over all the business of both companies. Therefore, although the old company name remains in this document, it is a valid Renesas Electronics document. We appreciate your understanding.

Renesas Electronics website: <a href="http://www.renesas.com">http://www.renesas.com</a>

April 1<sup>st</sup>, 2010 Renesas Electronics Corporation

Issued by: Renesas Electronics Corporation (<a href="http://www.renesas.com">http://www.renesas.com</a>)

Send any inquiries to http://www.renesas.com/inquiry.



#### Notice

- 1. All information included in this document is current as of the date this document is issued. Such information, however, is subject to change without any prior notice. Before purchasing or using any Renesas Electronics products listed herein, please confirm the latest product information with a Renesas Electronics sales office. Also, please pay regular and careful attention to additional and different information to be disclosed by Renesas Electronics such as that disclosed through our website.
- Renesas Electronics does not assume any liability for infringement of patents, copyrights, or other intellectual property rights
  of third parties by or arising from the use of Renesas Electronics products or technical information described in this document.
  No license, express, implied or otherwise, is granted hereby under any patents, copyrights or other intellectual property rights
  of Renesas Electronics or others.
- 3. You should not alter, modify, copy, or otherwise misappropriate any Renesas Electronics product, whether in whole or in part.
- 4. Descriptions of circuits, software and other related information in this document are provided only to illustrate the operation of semiconductor products and application examples. You are fully responsible for the incorporation of these circuits, software, and information in the design of your equipment. Renesas Electronics assumes no responsibility for any losses incurred by you or third parties arising from the use of these circuits, software, or information.
- 5. When exporting the products or technology described in this document, you should comply with the applicable export control laws and regulations and follow the procedures required by such laws and regulations. You should not use Renesas Electronics products or the technology described in this document for any purpose relating to military applications or use by the military, including but not limited to the development of weapons of mass destruction. Renesas Electronics products and technology may not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable domestic or foreign laws or regulations.
- 6. Renesas Electronics has used reasonable care in preparing the information included in this document, but Renesas Electronics does not warrant that such information is error free. Renesas Electronics assumes no liability whatsoever for any damages incurred by you resulting from errors in or omissions from the information included herein.
- 7. Renesas Electronics products are classified according to the following three quality grades: "Standard", "High Quality", and "Specific". The recommended applications for each Renesas Electronics product depends on the product's quality grade, as indicated below. You must check the quality grade of each Renesas Electronics product before using it in a particular application. You may not use any Renesas Electronics product for any application categorized as "Specific" without the prior written consent of Renesas Electronics. Further, you may not use any Renesas Electronics product for any application for which it is not intended without the prior written consent of Renesas Electronics. Renesas Electronics shall not be in any way liable for any damages or losses incurred by you or third parties arising from the use of any Renesas Electronics product for an application categorized as "Specific" or for which the product is not intended where you have failed to obtain the prior written consent of Renesas Electronics. The quality grade of each Renesas Electronics product is "Standard" unless otherwise expressly specified in a Renesas Electronics data sheets or data books, etc.
  - "Standard": Computers; office equipment; communications equipment; test and measurement equipment; audio and visual equipment; home electronic appliances; machine tools; personal electronic equipment; and industrial robots.
  - "High Quality": Transportation equipment (automobiles, trains, ships, etc.); traffic control systems; anti-disaster systems; anti-crime systems; safety equipment; and medical equipment not specifically designed for life support.
  - "Specific": Aircraft; aerospace equipment; submersible repeaters; nuclear reactor control systems; medical equipment or systems for life support (e.g. artificial life support devices or systems), surgical implantations, or healthcare intervention (e.g. excision, etc.), and any other applications or purposes that pose a direct threat to human life.
- 8. You should use the Renesas Electronics products described in this document within the range specified by Renesas Electronics, especially with respect to the maximum rating, operating supply voltage range, movement power voltage range, heat radiation characteristics, installation and other product characteristics. Renesas Electronics shall have no liability for malfunctions or damages arising out of the use of Renesas Electronics products beyond such specified ranges.
- 9. Although Renesas Electronics endeavors to improve the quality and reliability of its products, semiconductor products have specific characteristics such as the occurrence of failure at a certain rate and malfunctions under certain use conditions. Further, Renesas Electronics products are not subject to radiation resistance design. Please be sure to implement safety measures to guard them against the possibility of physical injury, and injury or damage caused by fire in the event of the failure of a Renesas Electronics product, such as safety design for hardware and software including but not limited to redundancy, fire control and malfunction prevention, appropriate treatment for aging degradation or any other appropriate measures. Because the evaluation of microcomputer software alone is very difficult, please evaluate the safety of the final products or system manufactured by you.
- 10. Please contact a Renesas Electronics sales office for details as to environmental matters such as the environmental compatibility of each Renesas Electronics product. Please use Renesas Electronics products in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. Renesas Electronics assumes no liability for damages or losses occurring as a result of your noncompliance with applicable laws and regulations.
- 11. This document may not be reproduced or duplicated, in any form, in whole or in part, without prior written consent of Renesas Electronics
- 12. Please contact a Renesas Electronics sales office if you have any questions regarding the information contained in this document or Renesas Electronics products, or if you have any other inquiries.
- (Note 1) "Renesas Electronics" as used in this document means Renesas Electronics Corporation and also includes its majority-owned subsidiaries.
- (Note 2) "Renesas Electronics product(s)" means any product developed or manufactured by or for Renesas Electronics.

# Regarding the change of names mentioned in the document, such as Mitsubishi Electric and Mitsubishi XX, to Renesas Technology Corp.

The semiconductor operations of Hitachi and Mitsubishi Electric were transferred to Renesas Technology Corporation on April 1st 2003. These operations include microcomputer, logic, analog and discrete devices, and memory chips other than DRAMs (flash memory, SRAMs etc.) Accordingly, although Mitsubishi Electric, Mitsubishi Electric Corporation, Mitsubishi Semiconductors, and other Mitsubishi brand names are mentioned in the document, these names have in fact all been changed to Renesas Technology Corp. Thank you for your understanding. Except for our corporate trademark, logo and corporate statement, no changes whatsoever have been made to the contents of the document, and these changes do not constitute any alteration to the contents of the document itself.

Note: Mitsubishi Electric will continue the business operations of high frequency & optical devices and power devices.

Renesas Technology Corp. Customer Support Dept. April 1, 2003



#### **DESCRIPTION**

The 7630 group is a single chip 8-bit microcomputer designed with CMOS silicon gate technology.

Being equipped with a CAN (Controller Area Network) module circuit, the microcomputer is suited to drive automotive equipments. The CAN module complies with CAN specification version 2.0, part B and allows priority-based message management.

In addition to the microcomputers simple instruction set, the ROM, RAM and I/O addresses are placed in the same memory map to enable easy programming.

The built-in ROM is available as mask ROM or One Time PROM. For development purposes, emulator- and EPROM-type microcomputers are available as well.

## **FEATURES**

•	Basic machine-language instructions
•	Minimum instruction execution time (at 10 MHz oscillation frequency)
•	Memory size           ROM
•	I/O ports
	Programmable I/O ports35
	Input

• Interrupts
<ul><li>Timers</li></ul>
16-bit Timers 2 channels
8-bit Timers
Serial I/Os
Clock synchronous
UART
CAN module
(CAN specification version 2.0, part B)1 channel
• A-D converter 8-bits x 8 channels
Watchdog timer
Clock Generating Circuit
Built-in with internal feedback resistor
Power source voltage
(at 10 MHz oscillation frequency) 4.0 to 5.5 V
Power dissipation
In high-speed mode
(at 8 MHz oscillation frequency, at 5 V power source voltage)
• Operating temperature range40 to 85 °C
• Package 44QFP (44P6N-A)

#### **APPLICATION**

Automotive controls

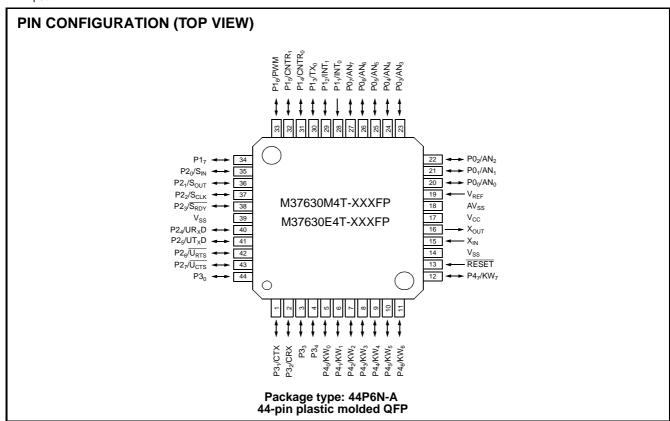
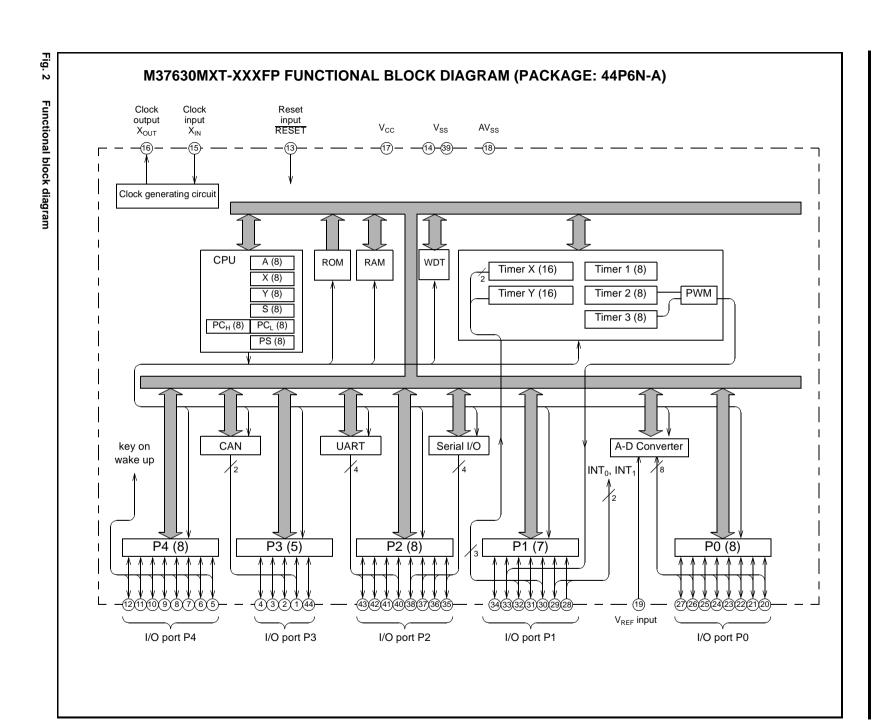


Fig. 1 Pin configuration of M37630M4T-XXXFP

MITSUBISHI MICROCOMPUTERS 7630 Group



# **PIN DESCRIPTION**

Table 1: Pin description

Pin	Name	Input/Output	Description		
V <sub>CC</sub> , V <sub>SS</sub>	Power source voltage		Power supply pins; apply 4.0 to 5.5 V to $V_{\text{CC}}$ and 0 V to $V_{\text{SS}}$		
$AV_SS$	Analog power source voltage		Ground pin for A-D converter. Connect to V <sub>SS</sub>		
RESET	Reset input	Input	Reset pin. This pin must be kept at "L" level for more than 2 $\mu$ s, to enter the reset state. If the crystal or ceramic resonator requires more time to stabilize, extend the "L" level period.		
X <sub>IN</sub>	Clock input	Input	Input and output pins of the internal clock generating circuit. Connect a ceramic or		
X <sub>OUT</sub>	Clock output	Output	quartz–crystal resonator between the $X_{\text{IN}}$ and $X_{\text{OUT}}$ pins. When an external clock source is used, connect it to $X_{\text{IN}}$ and leave $X_{\text{OUT}}$ open.		
$V_{REF}$	Reference voltage input	Input	Reference voltage input pin for A-D converter		
P0 <sub>0</sub> /AN <sub>0</sub> — P0 <sub>7</sub> /AN <sub>7</sub>	I/O port P0	I/O	CMOS I/O ports or analog input ports		
P1 <sub>1</sub> /INT <sub>0</sub>		Input	CMOS input port or external interrupt input port. The active edge (rising or falling) o external interrupts can be selected. This pin will be used as V <sub>PP</sub> pin during PROM programming of One Time PROM Versions.		
P1 <sub>2</sub> /INT <sub>1</sub>		I/O	CMOS I/O port or external interrupt input port. The active edge (rising or falling) of external interrupts can be selected.		
P1 <sub>3</sub> /TX <sub>0</sub>			CMOS I/O port or input pin used in the bi-phase counter mode		
P1 <sub>4</sub> /CNTR <sub>0</sub>	I/O port P1		CMOS I/O port or timer X input pin used for the event counter, pulse width measurement and bi-phase counter mode		
P1 <sub>5</sub> /CNTR <sub>1</sub>			CMOS I/O port or timer Y input pin used for the event counter, pulse width and pulse period measurement mode		
P1 <sub>6</sub> /PWM			CMOS I/O port or PWM output pin used in the PWM mode of timers 2 and 3		
P1 <sub>7</sub>			CMOS I/O port		
P2 <sub>0</sub> /S <sub>IN</sub> P2 <sub>1</sub> /S <sub>OUT</sub> P2 <sub>2</sub> /S <sub>CLK</sub> P2 <sub>3</sub> /S <sub>RDY</sub>		NO 100 NO	LIO.	CMOS I/O ports or clock synchronous serial I/O pins	
P2 <sub>4</sub> /UR <sub>X</sub> D P2 <sub>5</sub> /UT <sub>X</sub> D P2 <sub>6</sub> /U <sub>RTS</sub> P2 <sub>7</sub> /U <sub>CTS</sub>	I/O port P2	I/O	CMOS I/O ports or asynchronous serial I/O pins		
P3 <sub>0</sub>			CMOS I/O port		
P3 <sub>1</sub> /CTX	I/O port P3	1/0	CMOS I/O port or CAN transmit data pin		
P3 <sub>2</sub> /CRX			CMOS I/O port or CAN receive data pin		
P3 <sub>3</sub> —P3 <sub>4</sub>	1		CMOS I/O port		
P4 <sub>0</sub> /KW <sub>0</sub> — P4 <sub>7</sub> /KW <sub>7</sub>	I/O port P4	I/O	CMOS I/O ports. These ports can be used for key-on wake-up when configured as inputs.		



# **PART NUMBERING**

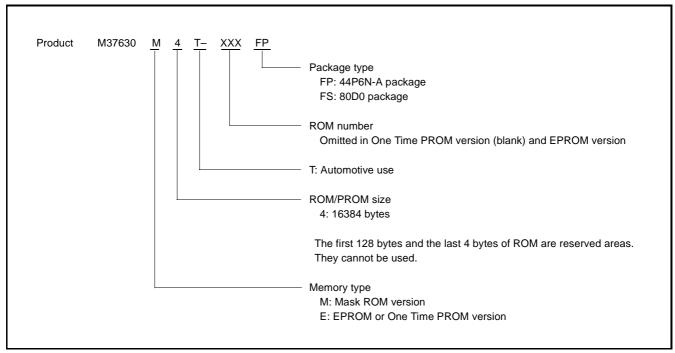


Fig. 3 Part numbering



# **GROUP EXPANSION**

Mitsubishi plans to expand the 7630 group as follows:

# **Memory Type**

Support mask ROM, One Time PROM and EPROM versions.

# **Memory Size**

ROM/PROM size	. 16 Kbytes
RAM size	512 bytes

#### **Package**

44P6N-A	0.8mm-pitch plastic molded QFP
80D0 0.8mm-pi	tch ceramic LCC (EPROM version)

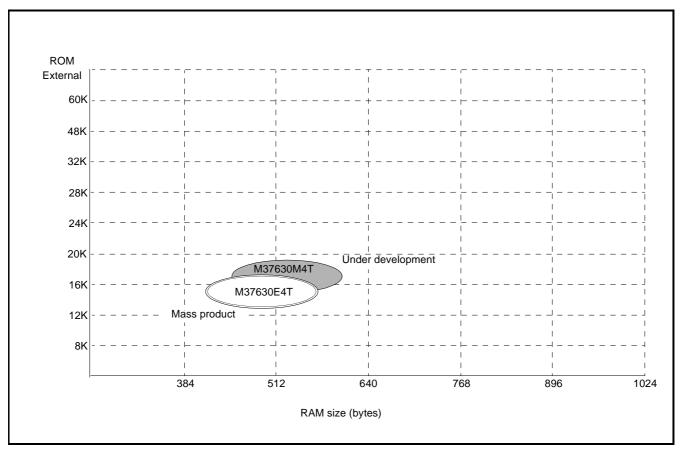


Fig. 4 Memory expansion plan

Currently supported products are listed below:

Table 2: List of supported products

As of March 1998

Product	(P)ROM size (bytes) ROM size for User ()	RAM size (bytes)	Package	Remarks
M37630M4T-XXXFP				Mask ROM version
M37630E4T-XXXFP	16384	512	44P6N-A	One Time PROM version
M37630E4FP	(16252)			One Time PROM version (blank)
M37630E4FS			80D0	EPROM version



#### **FUNCTIONAL DESCRIPTION**

#### **Central Processing Unit (CPU)**

The core of 7630 group microcomputers is the 7600 series CPU. This core is based on the standard instruction set of 740 series; however the performance is improved by allowing to execute the same instructions as that of the 740 series in less cycles. Refer to the 7600 Series Software Manual for details of the instruction set.

#### **CPU Mode Register CPUM**

The CPU mode register contains the stack page selection bit and internal system clock selection bit. The CPU mode register is allocated to address 0000<sub>16</sub>.

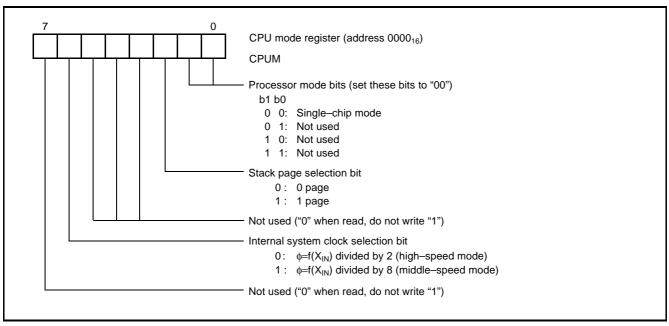


Fig. 5 Structure of CPU mode register



#### **MEMORY**

#### Special Function Register (SFR) Area

The special function register (SFR) area contains the registers relating to functions such as I/O ports and timers.

#### RAM

RAM is used for data storage and for stack area of subroutine calls and interrupts.

#### ROM

ROM is used for storing user's program code as well as the interrupt vector area.

#### **Interrupt Vector Area**

The interrupt vector area is for storing jump destination addresses used at reset or when an interrupt is generated.

#### **Zero Page**

This area can be accessed most efficiently by means of the zero page addressing mode.

#### **Special Page**

This area can be accessed most efficiently by means of the special page addressing mode.

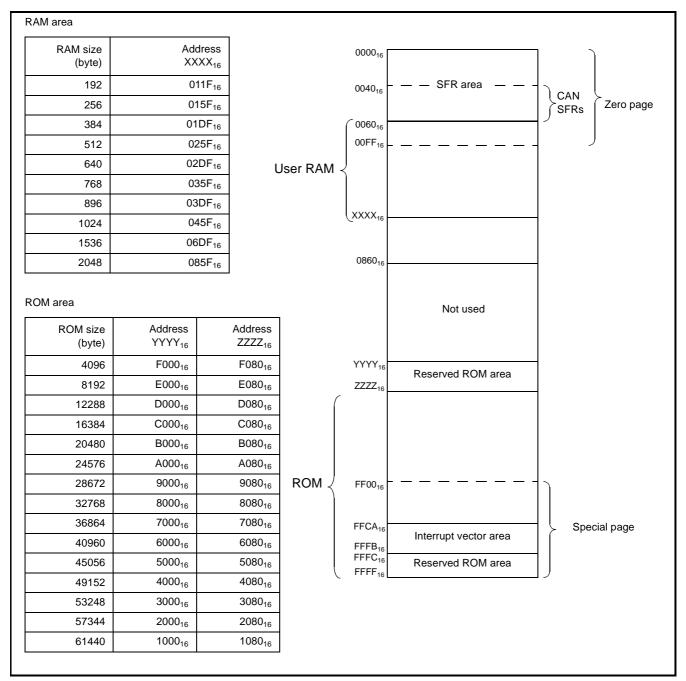


Fig. 6 Memory map diagram



# **SPECIAL FUNCTION REGISTERS (SFR)**

0000 <sub>16</sub>	CPU mode register	CPUM	0030 <sub>16</sub> CAN transmit control register CTRM
0001 <sub>16</sub>	Not used		0031 <sub>16</sub> CAN bus timing control register 1 CBTCON
0002 <sub>16</sub>	Interrupt request register A	IREQA	0032 <sub>16</sub> CAN bus timing control register 2 CBTCON:
0003 <sub>16</sub>	Interrupt request register B	IREQB	0033 <sub>16</sub> CAN acceptance code register 0 CAC
0004 <sub>16</sub>	Interrupt request register C	IREQC	0034 <sub>16</sub> CAN acceptance code register 1 CAC
0005 <sub>16</sub>	Interrupt control register A	ICONA	0035 <sub>16</sub> CAN acceptance code register 2 CAC
0006 <sub>16</sub>	Interrupt control register B	ICONB	0036 <sub>16</sub> CAN acceptance code register 3 CAC
0007 <sub>16</sub>	Interrupt control register C	ICONC	0037 <sub>16</sub> CAN acceptance code register 4 CAC
0008 <sub>16</sub>	Port P0 register	P0	0038 <sub>16</sub> CAN acceptance mask register 0 CAM
0009 <sub>16</sub>	Port P0 direction register	P0D	0039 <sub>16</sub> CAN acceptance mask register 1 CAM
000A <sub>16</sub>	Port P1 register	P1	003A <sub>16</sub> CAN acceptance mask register 2 CAM
	Port P1 direction register	P1D	003B <sub>16</sub> CAN acceptance mask register 3 CAM
	Port P2 register	P2	003C <sub>16</sub> CAN acceptance mask register 4 CAM
	Port P2 direction register	P2D	003D <sub>16</sub> CAN receive control register CREC
	Port P3 register	P3	003E <sub>16</sub> CAN transmit abort register CABOR
	Port P3 direction register	P3D	003F <sub>16</sub> Reserved
	Port P4 register	P4	0040 <sub>16</sub> CAN transmit buffer register 0 CTB
	Port P4 direction register	P4D	0041 <sub>16</sub> CAN transmit buffer register 1 CTB
	Serial I/O shift register	SIO	0042 <sub>16</sub> CAN transmit buffer register 2 CTB:
	Serial I/O control register	SIOCON	0043 <sub>16</sub> CAN transmit buffer register 3 CTB
	A-D conversion register	AD	0044 <sub>16</sub> CAN transmit buffer register 4 CTB
	A-D control register	ADCON	0045 <sub>16</sub> CAN transmit buffer register 5 CTB
	Timer 1	T1	0046 <sub>16</sub> CAN transmit buffer register 6 CTB
	Timer 2	T2	0047 <sub>16</sub> CAN transmit buffer register 7 CTB
	Timer 3	T3	0048 <sub>16</sub> CAN transmit buffer register 8 CTB
	Timer 123 mode register	T123M	0049 <sub>16</sub> CAN transmit buffer register 9 CTB
	Timer XL	TXL	004A <sub>16</sub> CAN transmit buffer register A CTB/
	Timer XH	TXH	004B <sub>16</sub> CAN transmit buffer register B CTB
	Timer YL	TYL	004C <sub>16</sub> CAN transmit buffer register C CTB0
	Timer YH	TYH	004D <sub>16</sub> CAN transmit buffer register D CTBI
	Timer X mode register	TXM	004E <sub>16</sub> Reserved
	Timer Y mode register	TYM	004F <sub>16</sub> Reserved
	UART mode register	UMOD	0050 <sub>16</sub> CAN receive buffer register 0 CRB
	UART baud rate generator	UBRG	0051 <sub>16</sub> CAN receive buffer register 1 CRB
	UART control register	UCON	0052 <sub>16</sub> CAN receive buffer register 2 CRB:
	UART status register	USTS	0052 <sub>16</sub> CAN receive buffer register 3 CRB:
	UART transmit buffer register 1	UTBR1	0054 <sub>16</sub> CAN receive buffer register 4 CRB
	UART transmit buffer register 2	UTBR2	0055 <sub>16</sub> CAN receive buffer register 5 CRB
	UART receive buffer register 1	URBR1	0056 <sub>16</sub> CAN receive buffer register 6 CRB
	UART receive buffer register 2	URBR2	0057 <sub>16</sub> CAN receive buffer register 7 CRB
	Port P0 pull-up control register	PUP0	0057 <sub>16</sub> CAN receive buffer register 7 CRB
	Port P1 pull-up control register	PUP1	0059 <sub>16</sub> CAN receive buffer register 9 CRB:
	Port P2 pull-up control register	PUP1	
	Port P3 pull-up control register	PUP2 PUP3	005A <sub>16</sub> CAN receive buffer register A CRB/
			005B <sub>16</sub> CAN receive buffer register B CRB
	Port P4 pull-up/down control register	PUP4	005C <sub>16</sub> CAN receive buffer register C CRB0
	Interrupt polarity selection register	IPOL	005D <sub>16</sub> CAN receive buffer register D CRBI
	Watchdog timer register	WDT	005E <sub>16</sub> Reserved
002F <sub>16</sub>	Polarity control register	PCON	005F <sub>16</sub> Reserved

Fig. 7 Memory map of special register (SFR)



# I/O PORTS

The 7630 group has 35 programmable I/O pins and one input pin arranged in five I/O ports (ports P0 to P4). The I/O ports are controlled by the corresponding port registers and port direction registers; each I/O pin can be controlled separately.

When data is read from a port configured as an output port, the port latch's contents are read instead of the port level. A port configured

as an input port becomes floating and its level can be read. Data written to this port will affect the port latch only; the port remains floating.

Refer to Structure of port- and port direction registers, Structure of port I/Os (1) and Structure of port I/Os (2).

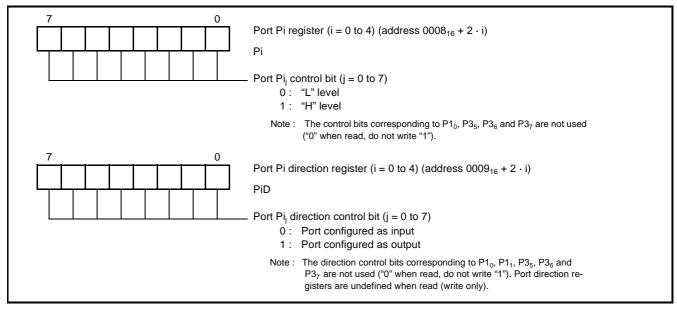


Fig. 8 Structure of port- and port direction registers



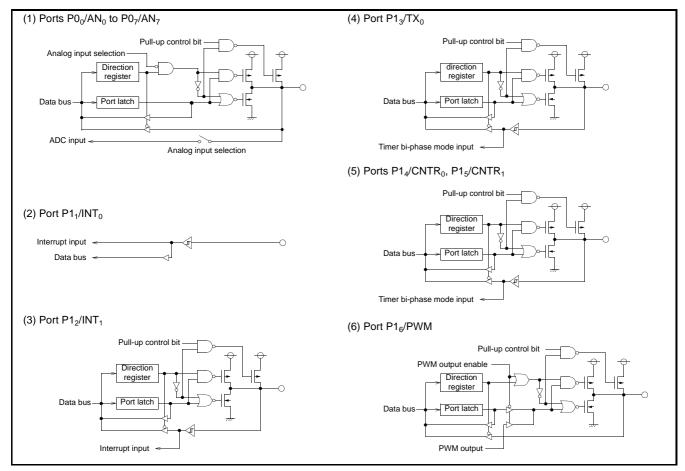


Fig. 9 Structure of port I/Os (1)



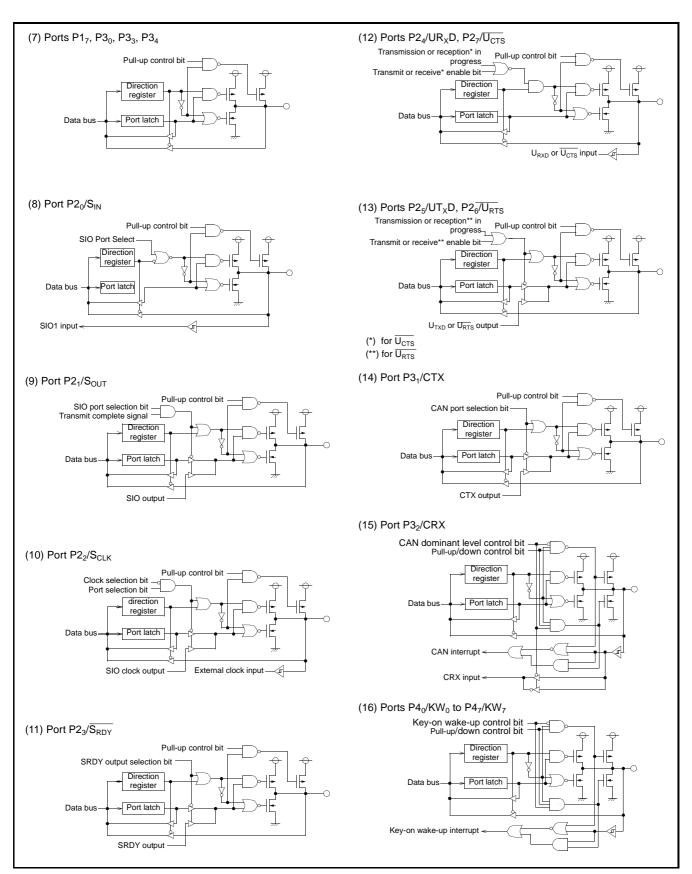


Fig. 10 Structure of port I/Os (2)

#### Port Pull-up/pull-down Function

Each pin of ports P0 to P4 except P1 $_1$  is equipped with a programmable pull-up transistor. P3 $_2$ /CRX and P4 $_0$ /KW $_0$  to P4 $_7$ /KW $_7$  are equipped with programmable pull-down transistors as well. The pull-up function of P0 to P3 can be controlled by the corresponding

port pull-up control registers (see Structure of port pull-up/down control registers). The pull-up/down function of ports  $P3_2$  and P4 can be controlled by the corresponding port pull-up/pull-down registers together with the polarity control register (see Structure of polarity control register).

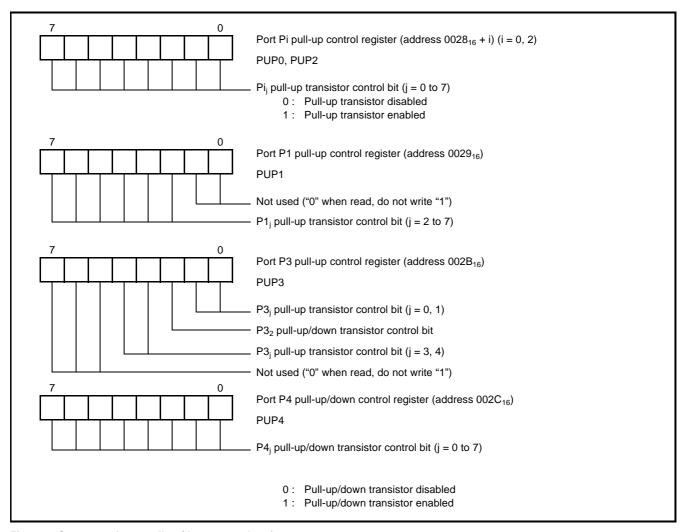


Fig. 11 Structure of port pull-up/down control registers

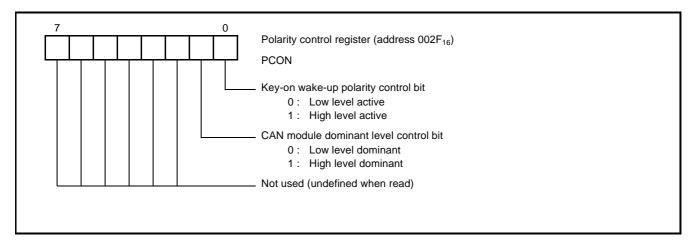


Fig. 12 Structure of polarity control register



#### **Port Overvoltage Application**

When configured as input ports, P1 to P4 may be subjected to overvoltage ( $V_I > V_{CC}$ ) if the input current to the applicable port is limited to the specified values (see "Table 8:"). Use a serial resistor of appropriate size to limit the input current. To estimate the resistor value, assume the port voltage to be  $V_{CC}$  at overvoltage condition.

#### Notes:

• Subjecting ports to overvoltage may effect the supply voltage. Assure to keep  $V_{\rm CC}$  and  $V_{\rm SS}$  within the target limits.

- Avoid to subject ports to overvoltage causing  $V_{\text{CC}}$  to rise above  $5.5\,\text{V}$
- The overvoltage condition causing input current flowing through the internal port protection circuits has a negative effect on the ports noise immunity. Therefore, careful and intense testing of the target system's noise immunity is required. Refer to the "countermeasures against noise" of the corresponding users manual
- Port P0 must not be subjected to overvoltage conditions.



#### **INTERRUPTS**

There are 24 interrupts: 6 external, 17 internal, and 1 software.

#### **Interrupt Control**

Each interrupt except the BRK instruction interrupt has both an interrupt request bit and an interrupt enable bit, and is controlled by the interrupt disable flag. An interrupt occurs when the corresponding interrupt request and enable bits are "1" and the interrupt disable flag is "0". Interrupt enable bits can be cleared or set by software. Interrupt request bits can be cleared by software but cannot be set by software. The BRK instruction interrupt and reset cannot be disabled with any flag or bit. The I flag disables all interrupts except the BRK instruction interrupt and reset. If several interrupt requests occur at the same time, the interrupt with the highest priority is accepted first.

# **Interrupt Operation**

Upon acceptance of an interrupt, the following operations are automatically performed.

1. The processing being executed is stopped.

- The contents of the program counter and processor status register are automatically pushed onto the stack.
- Concurrently with the push operation, the interrupt jump destination address is read from the vector table into the program counter.
- The interrupt disable flag is set and the corresponding interrupt request bit is cleared.

#### Notes on use

When the active edge of an external interrupt ( $INT_0$ ,  $INT_1$ ,  $CNTR_0$ ,  $CNTR_1$ , CWKU or KOI) is changed, the corresponding interrupt request bit may also be set. Therefore, take the following sequence.

- (1) Disable the external interrupt which is selected.
- (2) Change the active edge in interrupt edge selection register. (in the case of CNTR<sub>0</sub>: Timer X mode register; in the case of CNTR<sub>1</sub>: Timer Y mode register)
- (3) Clear the interrupt request bit to "0".
- (4) Enable the external interrupt which is selected.



Table 3: Interrupt vector addresses and priority

Interment course	Priority	Vector Address (Note 1)		Interrupt Request Generating	Damada
Interrupt source		High	Low	Conditions	Remarks
Reset (Note 2)	1	FFFB <sub>16</sub>	FFFA <sub>16</sub>	At Reset	Non-maskable
Watchdog timer	2	FFF9 <sub>16</sub>	FFF8 <sub>16</sub>	At Watchdog timer underflow	Non-maskable
INT0	3	FFF7 <sub>16</sub>	FFF6 <sub>16</sub>	At detection of either rising or falling edge of INT <sub>0</sub> interrupt	External Interrupt (active edge selectable)
INT1	4	FFF5 <sub>16</sub>	FFF4 <sub>16</sub>	At detection of either rising or falling edge of INT <sub>1</sub> interrupt	External Interrupt (active edge selectable)
CAN successful transmit	5	FFF3 <sub>16</sub>	FFF2 <sub>16</sub>	At CAN module successful transmission of message	Valid when CAN module is activated and request transmit
CAN successful receive	6	FFF1 <sub>16</sub>	FFF0 <sub>16</sub>	At CAN module successful reception of message	Valid when CAN module is activated
CAN overrun	7	FFEF <sub>16</sub>	FFEE <sub>16</sub>	If CAN module receives message when receive buffers are full.	Valid when CAN module is activated
CAN error passive	8	FFED <sub>16</sub>	FFEC <sub>16</sub>	When CAN module enters into error passive state	Valid when CAN module is active
CAN error bus off	9	FFEB <sub>16</sub>	FFEA <sub>16</sub>	When CAN module enters into bus off state	Valid when CAN module is active
CAN wake up	10	FFE9 <sub>16</sub>	FFE8 <sub>16</sub>	When CAN module wakes up via CAN bus	
Timer X	11	FFE7 <sub>16</sub>	FFE6 <sub>16</sub>	At Timer X underflow or overflow	
Timer Y	12	FFE5 <sub>16</sub>	FFE4 <sub>16</sub>	At Timer Y underflow	
Timer 1	13	FFE3 <sub>16</sub>	FFE2 <sub>16</sub>	At Timer 1 underflow	
Timer 2	14	FFE1 <sub>16</sub>	FFE0 <sub>16</sub>	At Timer 2 underflow	
Timer 3	15	FFDF <sub>16</sub>	FFDE <sub>16</sub>	At Timer 3 underflow	
CNTR0	16	FFDD <sub>16</sub>	FFDC <sub>16</sub>	At detection of either rising or falling edge in CNTR <sub>0</sub> input	External Interrupt (active edge selectable)
CNTR1	17	FFDB <sub>16</sub>	FFDA <sub>16</sub>	At detection of either rising or falling edge in CNTR <sub>1</sub> input	External Interrupt (active edge selectable)
UART receive	18	FFD9 <sub>16</sub>	FFD8 <sub>16</sub>	At completion of UART receive	Valid when UART is selected
UART transmit	19	FFD7 <sub>16</sub>	FFD6 <sub>16</sub>	At completion of UART transmit	Valid when UART is selected
UART transmit buffer empty	20	FFD5 <sub>16</sub>	FFD4 <sub>16</sub>	At UART transmit buffer empty	Valid when UART is selected
UART receive error	21	FFD3 <sub>16</sub>	FFD2 <sub>16</sub>	When UART reception error occurs.	Valid when UART is selected
Serial I/O	22	FFD1 <sub>16</sub>	FFD0 <sub>16</sub>	At completion of serial I/O data transmit and receive	Valid when serial I/O is selected
A-D conversion	23	FFCF <sub>16</sub>	FFCE <sub>16</sub>	At completion of A-D conversion	
Key-on wake-up	24	FFCD <sub>16</sub>	FFCC <sub>16</sub>	At detection of either rising or falling edge of P4 input	External Interrupt (active edge selectable)
BRK instruction	25	FFCB <sub>16</sub>	FFCA <sub>16</sub>	At BRK instruction execution	Non-maskable

Notes 1: Vector addresses contain interrupt jump destination address

2: Reset function in the same way as an interrupt with the highest priority



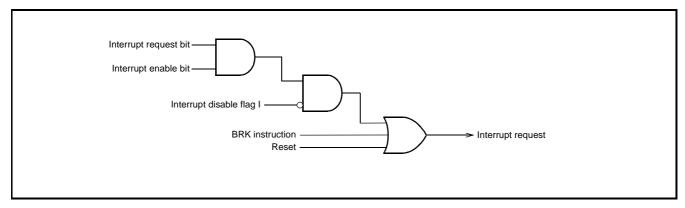


Fig. 13 Interrupt control

For the external interrupts INT0 and INT1, the active edge causing the interrupt request can be selected by the INT0 and INT1 interrupt edge selection bits of the interrupt polarity selection register (IPOL); please refer to Fig. 14 below.

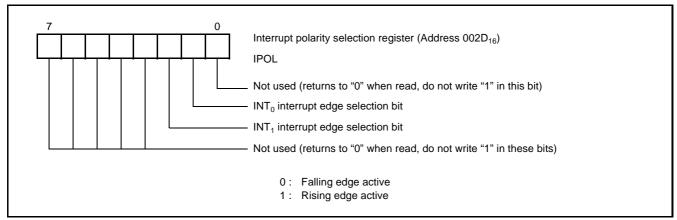


Fig. 14 Structure of interrupt polarity selection register



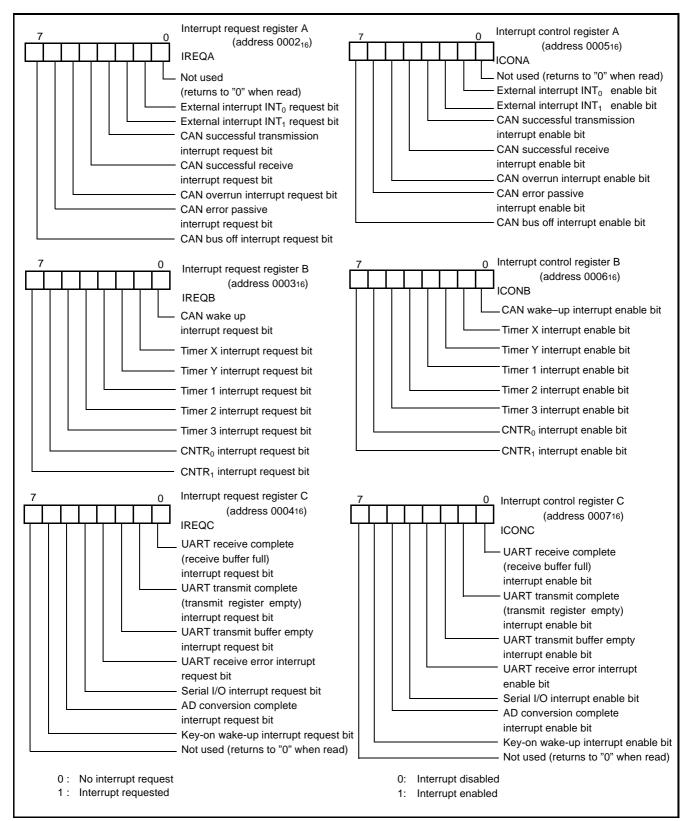


Fig. 15 Structure of interrupt request and control registers A, B and C



# **KEY-ON WAKE-UP**

"Key-on wake-up" is one way of returning from a power-down state caused by the STP or WIT instruction. Any terminal of port P4 can be used to generate the key-on wake-up interrupt request. The active polarity can be selected by the key-on wake-up polarity con-

trol bit of PCON (see Fig. 12). If any pin of port P4 has the selected active level applied, the key-on wake-up interrupt request will be set to "1". Please refer to Fig. 16.

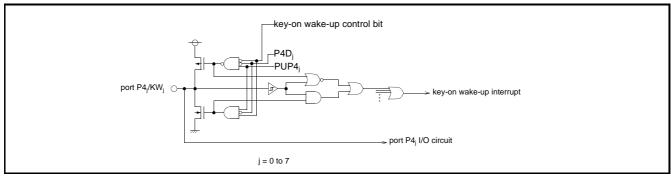


Fig. 16 Block diagram of key-on wake-up circuit



#### **TIMERS**

The 7630 group has five timers: two 16-bit timers and three 8-bit timers. All these timers will be described in detail below.

#### 16-bit Timers

Timers X and Y are 16-bit timers with multiple operating modes. Please refer to Fig. 17.

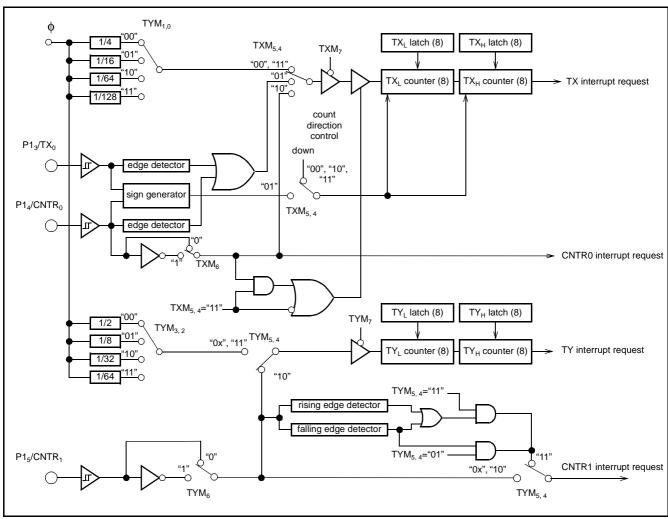


Fig. 17 Block diagram of timers X and Y (φ is internal system clock)

#### Timer X

Timer X is a 16-bit timer with a 16-bit reload latch supporting the following operating modes:

- (1) Timer mode
- (2) Bi-phase counter mode
- (3) Event counter mode
- (4) Pulse width measurement mode

These modes can be selected by the timer X mode register (TXM). In the timer- and pulse width measurement mode, the timer's count source can be selected by the timer X count source selection bits of the timer Y mode register (TYM). Please refer to the Figures below for the TXM and TYM bit assignment.

On read or write access to timer X, note that the high-order and loworder bytes must be accessed in the specific order.

#### Write method

When writing to the timer X, write the low-order byte first. The data written is stored in a temporary register which is assigned to the

same address as  $TX_L$ . Next, write the high-order byte. When this is finished, the data is placed in the timer X high-order reload latch and the low-order byte is transferred from its temporary register to the timer X low-order reload latch. Depending on the timer X write control bit, the latch contents are reloaded to the timer immediately (write control bit = "0") or on the next timer underflow (write control bit = "1").

#### Read method

When reading the timer X, read the high-order byte first. This causes the timer X high- and low-order bytes to be transferred to temporary registers being assigned to the same addresses as  $\mathsf{TX}_H$  and  $\mathsf{TX}_L$ . Next, read the low-order byte which is read from the temporary register. This method assures the correct timer value can be read during the timer count operation.

#### Timer X count stop control

Regardless of the actual operating mode, timer X can be stopped by setting the timer X count stop bit (bit 7 of the timer X mode register) to "1".



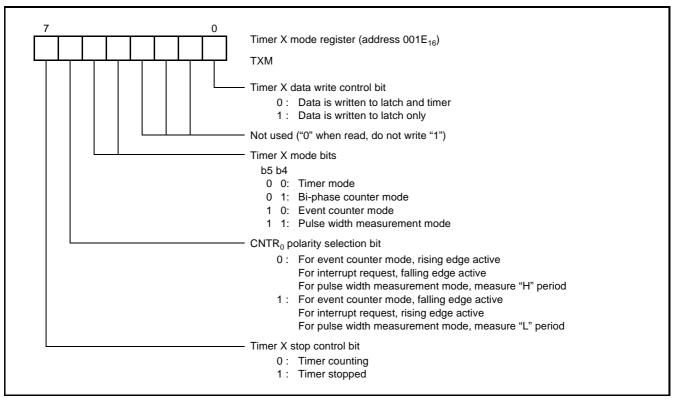


Fig. 18 Structure of Timer X mode register

#### Timer Y

Timer Y is a 16 bit timer with a 16-bit reload latch supporting the following operating modes:

- (1) Timer mode
- (3) Event counter mode
- (5) Pulse period measurement mode
- (6) H/L pulse width measurement mode

These modes can be selected by the timer Y mode register (TYM). In the timer, pulse period- and pulse width measurement modes' the timer's count source can be selected by the timer Y count source selection bits. Please refer to Fig. 19.

On read or write access to timer Y, note that the high-order and loworder bytes must be accessed in a specific order.

#### Write method

When writing to timer Y, write the low-order byte first. The data written is stored in a temporary register which is assigned to the same address as  $TY_L$ . Next, write the high-order byte. When this is finished, the data is placed in the timer Y high-order reload latch and the low-order byte is transferred from its temporary register to the timer Y low-order reload latch.

#### Read method

When reading the timer Y, read the high-order byte first. This causes the timer Y high- and low-order bytes to be transferred to temporary registers being assigned to the same addresses as  $\mathsf{TY}_\mathsf{H}$  and  $\mathsf{TY}_\mathsf{L}.$  Next, read the low-order byte which is read from the temporary register. This method assures the correct timer value can be read during timer count operation.

### Timer Y count stop control

Regardless of the actual operating mode, timer Y can be stopped by setting the timer Y count stop bit (bit 7 of the timer Y mode register) to "1".



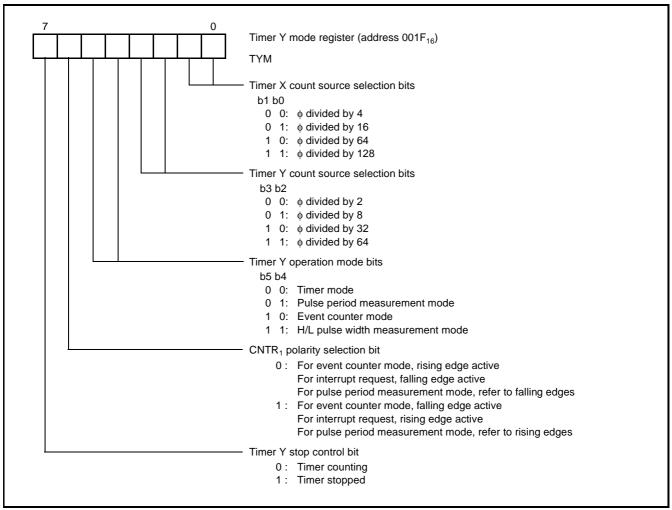


Fig. 19 Structure of timer Y mode register ( $\phi$  is internal system clock)

## **Operating Modes**

#### (1) Timer mode

This mode is available with timer X and timer Y.

Count source

The count source for timer X and Y is the output of the corresponding clock divider. The division ratio can be selected by the timer Y mode register.

• Operation

Both timers X and Y are down counters. On a timer underflow, the corresponding timer interrupt request bit will be set to "1", the contents of the corresponding timer latches will be reloaded to the counters and counting continues.

# (2) Bi-phase counter mode (quadruplicate)

This mode is available with timer X only.

- · Count source
  - The count sources are P1<sub>4</sub>/CNTR<sub>0</sub> and the P1<sub>3</sub>/TX<sub>0</sub> pins.
- Operation

Timer X will count both rising and falling edges on both input pins (see above). Refer to Timer X bi-phase counter mode operation for the timing chart of the bi-phase counter mode.

The count direction is determined by the edge polarity and level of count source inputs and may change during the count operation. Refer to the table below.

Table 4: Timer X count direction in Bi-phase counter mode

P1 <sub>3</sub> /TX <sub>0</sub>	P1 <sub>4</sub> /CNTR <sub>0</sub>	Count direction
↑ Edge	L	Up
Luge	Н	Down
↓ Edge	L	Down
↓ Luge	Н	Up
L	L ↑ Edge	Down
Н	Luge	Up
L	- ↓ Edge	Up
Н	↓ Euge	Down

On a timer over- or underflow, the corresponding interrupt request bit will be set to "1" and counting continues.



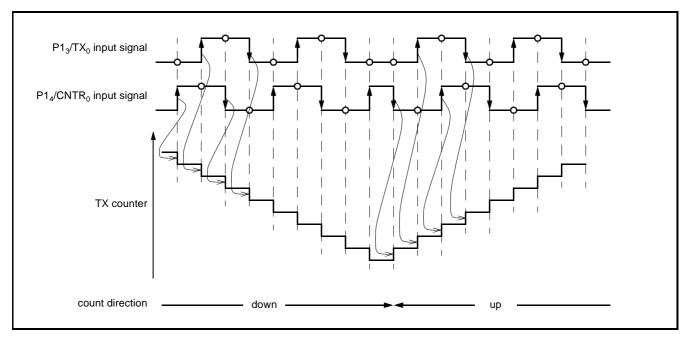


Fig. 20 Timer X bi-phase counter mode operation

### (3) Event counter mode

This mode is available with timer X and timer Y.

Count source

The count source for timer X is the input signal to the  $P1_4/CNTR_0$  pin and for timer Y the input signal to  $P1_5/CNTR_1$  pin.

Operation

The timer counts down. On a timer underflow, the corresponding timer interrupt request bit will be set to "1", the contents of the corresponding timer latches will be reloaded to the counters and counting continues. The active edge used for counting can be selected by the polarity selection bit of the corresponding pin P1<sub>4</sub>/CNTR<sub>0</sub> or P1<sub>5</sub>/CNTR<sub>1</sub>. These bits are part of TXM (Structure of Timer X mode register) and TYM (Structure of timer Y mode register (f is internal system clock)) registers.

#### (4) Pulse width measurement mode

This mode is available with timer X only.

Count source

The count source is the output of timer X clock divider. The division ratio can be selected by the timer Y mode register.

• Operation

The timer counts down while the input signal level on  $P1_4/CNTR_0$  matches the active polarity selected by the  $CNTR_0$  polarity selection bit of TXM (Structure of Timer X mode register). On a timer underflow, the timer X interrupt request bit will be set to "1", the contents of the timer latches are reloaded to the counters and counting continues. When the input level changes from active polarity (as selected), the  $CNTR_0$  interrupt request bit will be set to "1." The measurement result may be obtained by reading timer X during interrupt service.

## (5) Pulse period measurement mode

This mode is available with timer Y only.

Count source

The count source is the output of timer Y clock divider.

#### Operation

The active edge of input signal to be measured can be selected by  $CNTR_1$  polarity selection bit (Fig. 18). When this bit is set to "0", the time between two consecutive falling edges of the signal input to  $P1_5/CNTR_1$  pin will be measured, when the polarity bit is set to "1", the time between two consecutive rising edges will be measured.

The timer counts down. On detection of an active edge of input signal, the contents of the TY counters will be transferred to temporary registers assigned to the same addresses as TY. At the same time, the contents of TY latches will be reloaded to the counters and counting continues. The active edge of input signal also causes the  ${\rm CNTR}_1$  interrupt request bit to be set to "1". The measurement result may be obtained by reading timer Y during interrupt service.

#### (6) H/L pulse width measurement mode

This mode is available with timer Y only.

Count source

The count source is the output of the timer Y's clock divider.

#### Operation

This mode measures both the "H" and "L" periods of a signal input to  $P1_5/CNTR_1$  pin continuously. On detection of any edge (rising or falling) of input signal to  $P1_5/CNTR_1$  pin, the contents of timer Y counters are stored to temporary registers which are assigned to the same addresses as timer Y. At the same time, the contents of timer Y latches are reloaded to the counters and counting continues. The detection of an edge causes the CNTR1 interrupt request bit to be set to "1" as well. The result of measurement may be obtained by reading timer Y during interrupt service. This read access will address the temporary registers. On a timer underflow, the timer Y interrupt request bit will be set to "1", the contents of timer Y latches will be transferred to the counters and counting continues.



# TIMER 1, TIMER 2, TIMER 3

Timers 1 to 3 are 8-bit timers with 8-bit reload latches and one common pre-divider. Timer 1 can operate in the timer mode only,

whereas timers 2 and 3 can be used to generate a PWM output signal timing as well. Timers 1 to 3 are down count timers. See Fig. 21.

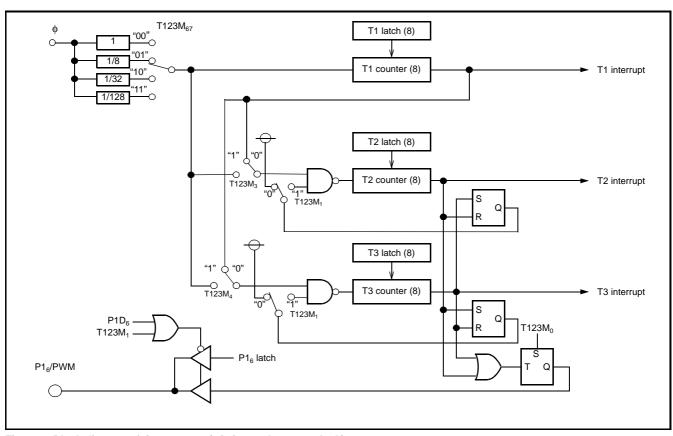


Fig. 21 Block diagram of timers 1 to 3 ( $\phi$  is internal system clock)

#### Timer 1

The count source of timer 1 is the output of timer 123 pre-divider. The division ratio of the pre-divider can be selected by the pre-divider division ratio bits of timer 123 mode register (T123M). Refer to Timer 123 mode register configuration (f is internal system clock). On a timer 1 underflow, the timer 1 interrupt request bit will be set to "1".

Writing to timer 1 initializes the latch and counter.

### Timers 2 and 3

The count source of timers 2 and 3 can be either the output of the timer 123 pre-divider or the timer 1 underflow. The count source can

be selected by the timer count source selection bits of timer 123 mode register (T123M).

Writing to timer 2 register affects the reload latch only or both of the reload latch and counter depending on the timer 2 write control bit of T123M. When the timer write control bit is set to "0", both latch and counter will be initialized simultaneously; when set to "1" only the reload latch will be initialized, on an underflow, the counter will be set to the modified reload value. Writing to timer 3 initializes latch and counter both.

Timer 2 or 3 underflow causes the timer 2 or 3 interrupt request bit to be set to "1".



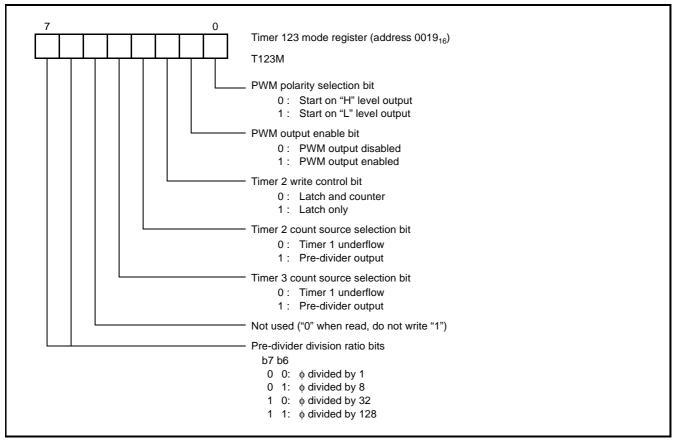


Fig. 22 Timer 123 mode register configuration (φ is internal system clock)

#### **Operating Modes**

# (1) Timer Mode

This mode is available with timers 1 to 3.

#### Count source

For timer 1, the count source is the output of the corresponding pre-divider. For timers 2 and 3, the count source can be separately selected to be either the pre-divider output or timer 1 underflow.

#### Operation

The timer counts down. On a timer underflow, the corresponding timer interrupt request bit will be set to "1", the contents of the corresponding timer latch will be reloaded to the counter and counting continues.

#### (2) PWM Mode

This mode is available with timer 2 and 3.

Count source

The count source can be separately selected to be either the pre-divider output or timer 1 underflow.

# Operation

When the PWM-mode is enabled, timer 2 starts counting. As soon as timer 2 underflows, timer 2 stops and timer 3 starts counting. If bit 0 is set, timer 2 determines the low duration and the initial output level is low. Timer 3 determines the high duration. If bit 0 is zero timer 2 determines the high duration and the initial output level is high. In this case timer 3 determines the low duration

Note: Be sure to configure the P1<sub>6</sub>/PWM pin as an output port before using PWM mode.



#### SERIAL I/Os

The serial I/O section of 7630 group consists of one clock synchronous and one asynchronous (UART) interface.

# Clock Synchronous Serial I/O (SI/O)

The clock synchronous interface allows full duplex communication based on 8 bit word length. The transfer clock can be selected from an internal or external clock. When an internal clock is selected, a programmable clock divider allows eight different transmission

speeds. Refer to Block diagram of clock synchronous I/O (f is internal system clock). The operation of the clock synchronous serial I/O can be configured by the serial I/O control register SIOCON; refer to Fig. 25.

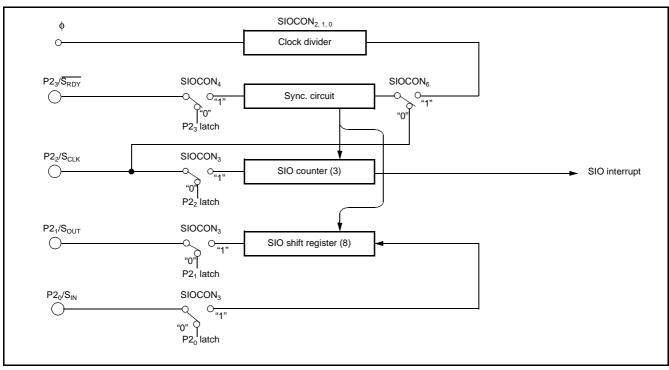


Fig. 23 Block diagram of clock synchronous I/O (\$\phi\$ is internal system clock)

#### (1) Clock synchronous serial I/O operation

Either an internal or external transfer clock can be selected by bit 6 of SIOCON. The internal clock divider can be programmed by bits 0 to 2 of SIOCON. Bit 3 of SIOCON determines whether the double function pins  $P2_0$  to  $P2_2$  will act as I/O ports or serve as SIO pins. Bit 4 of SIOCON allows the same selection for pin  $P2_3$ .

When an internal transfer clock is selected, transmission can be triggered by writing data to the SI/O shift register (SIO, address

 $0012_{16}$ ). After an 8-bit transmission has been completed, the  $\rm S_{OUT}$  pin will change to high impedance and the SIO interrupt request bit will be set to "1".

When an external transfer clock is selected, the SIO interrupt request bit will be set to "1" after 8 cycles but the contents of the SI/O shift register continue to be shifted while the transfer clock is being input. Therefore, the clock needs to be controlled externally; the  $S_{\text{OUT}}$  pin will not change to high impedance automatically.



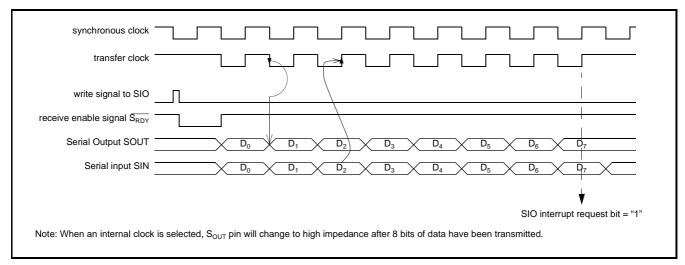


Fig. 24 Timing of clock synchronous SI/O function (LSB first selected)

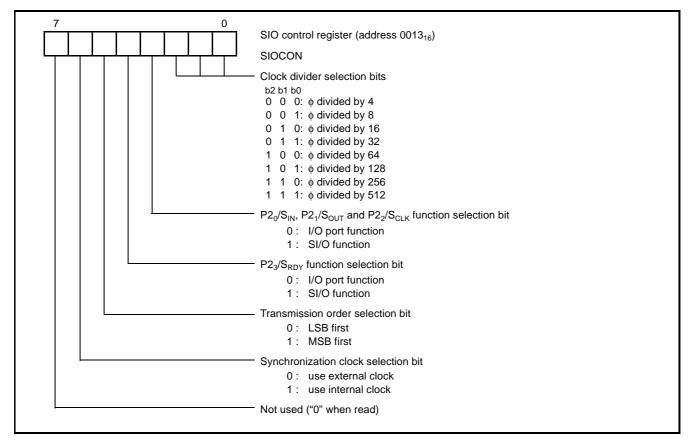


Fig. 25 Structure of serial I/O control register ( $\phi$  is internal system clock)

# Clock Asynchronous Serial I/O (UART)

The UART is a full duplex asynchronous transmit/receive unit. The built-in clock divider and baud rate generator enable a broad range of transmission speeds. Please refer to Block diagram of UART.

#### (1) Description

The transmit and receive shift registers have a buffer (consisting of high and low order byte) each. Since the shift registers cannot be

written to or read from directly, transmit data is written to the transmit buffer and receive data is read from the receive buffer. A transmit or receive operation will be triggered by the transmit enable bit and receive enable bit of the UART control register UCON (see Structure of UART control register). The double function terminals P2<sub>5</sub>/UT<sub>X</sub>D, P2<sub>6</sub>/URTS and P2<sub>4</sub>/UR<sub>X</sub>D, P2<sub>7</sub>/UCTS will be switched to serve as UART pins automatically.



#### (2) Baud rate selection

The baud rate of transmission and reception is determined by the setting of the prescaler and the contents of the UART baud rate generator register. It is calculated by: where p is the division ratio of

$$b = \frac{\phi}{16 \cdot p \cdot (n+1)}$$

the prescaler and n is the content of UART baud rate generator register. The prescalers division ration can be selected by the UART mode register (see below).

# UART mode register (UMOD, Structure of UART mode register)

The UART mode register allows to select the transmission and reception format with the following options:

word length: 7, 8 or 9 bitsparity: none, odd or even

stop bits: 1 or 2

It allows to select the prescalers division ratio as well.

#### **UART** baud rate generator (UBRG)

This 8 bit register allows to select the baud rate of the UART (see above). Set this register to the desired value before enabling reception or transmission.

# UART control register (UCON, Structure of UART control register)

The UART control register consists of four control bits (bit 0 to bit 3) which allow to control reception and transmission.

# **UART** status register (USTS, Structure of UART status register)

The read-only UART status register consists of 7 bits (bit 0 to bit 6) which indicate the operating status of the UART function and various errors.

#### (3) Handshaking signals

When used as transmitter the UART will recognize the clear-to-send signal via P2 $_7$ /UCTS terminal for handshaking. When used as receiver it will issue a request-to-send signal through P2 $_6$ /URTS pin.

#### Clear-to-send input

When used as a transmitter (transmit enable bit set to "1"), the UART starts transmission after recognizing "L" level on  $P2_7/UCTS$ . After started the UART will continue to transmit regardless of the actual level of  $P2_7/UCTS$  or status of the transmit enable bit.

#### Request-to-send output

The UART controls the  $P2_6/\overline{URTS}$  output according to the following conditions.

**Table 5: Output control conditions** 

Condition	P2 <sub>6</sub> /URTS
Receive enable bit is set to "1"	
Reception completed during receive enable bit set to "1"	"L"
Start bit (falling edge) detected	
Receive enable bit is set to "0" before reception started	"H"
Hardware reset	
Receive initialization bit is set to "1"	

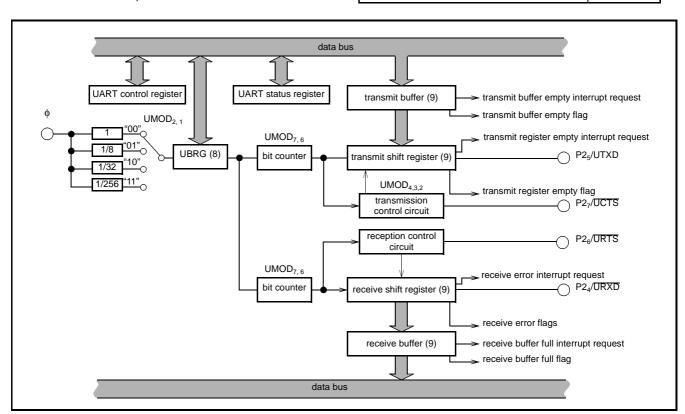


Fig. 26 Block diagram of UART



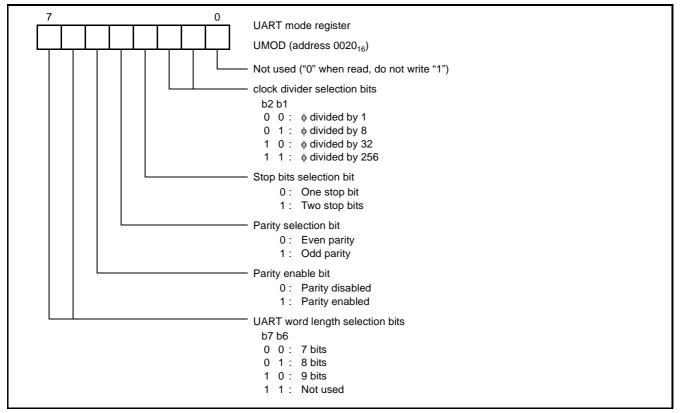


Fig. 27 Structure of UART mode register

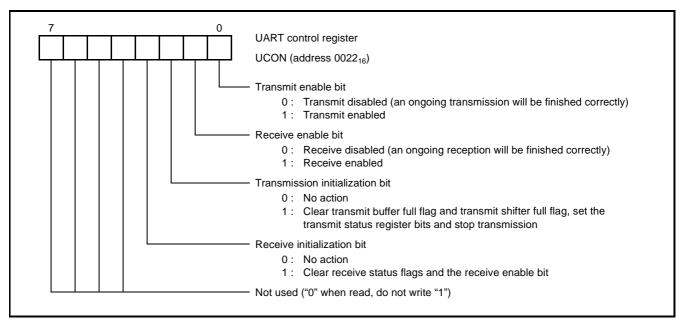


Fig. 28 Structure of UART control register



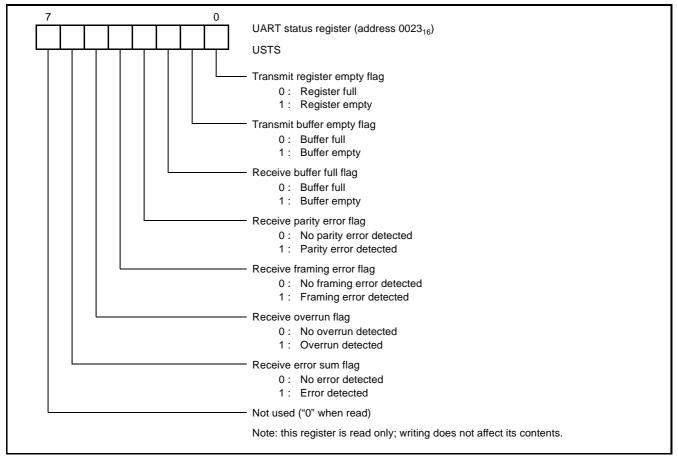


Fig. 29 Structure of UART status register

#### **CAN MODULE**

The CAN (Controller Area Network) interface of the 7630 group complies with the 2.0B specification, enabling reception and transmission of frames with either 11- or 29- bit identifier length. Refer to Fig. 31 for a block diagram of the CAN interface.

The programmer's interface to the CAN module is formed by three status/control registers (Fig. 32, Fig. 33, Fig. 34), two bus timing control registers (Fig. 35 Fig. 36), several registers for acceptance filtering (Fig. 37), the transmit and receive buffer registers (Fig. 38) and one dominant level control bit (Fig. 22).

#### **Baud Rate Selection**

A programmable clock prescaler is used to derive the CAN module's basic clock from the internal system clock frequency ( $\phi$ ). Bit 0 to bit 3 of the CAN bus timing control register represent the prescaler allowing a division ratio from 1 to 1/16 to be selected. So the CAN module basic clock frequency  $f_{\text{CANB}}$  can be calculated as follows:

$$f_{CANB} = \frac{\phi}{p+1}$$

where p is the value of the prescaler (selectable from 1 to 15). The effective baud rate of the CAN bus communication depends on the CAN bus timing control parameters and will be explained below.

#### **CAN Bus Timing Control**

Each bit-time consists of four different segments (see Fig. 30):

- Synchronization segment (SS),
- Propagation time segment (PTS),
- Phase buffer segment 1 (PBS1) and
- Phase buffer segment 2 (PBS2).

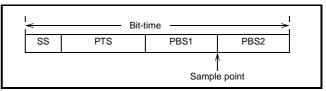


Fig. 30 Bit time of CAN module

The first of these segments is of fixed length (one Time Quantum) and the latter three can be programmed to be 1 to 8 Time Quanta by the CAN bus timing control register 1 and 2 (see Fig. 35 and Fig. 36). The whole bit-time has to consist of minimum 8 and maximum 25 Time Quanta. The duration of one Time Quantum is the cycle time of  $f_{CANB}$ . For example, assuming  $\phi = 5$  MHz, p = 0, one Time Quantum will be 200 ns long. This allows the maximum transmission rate of 625 kb/s to be reached (assuming 8 Time Quanta per bit-time).

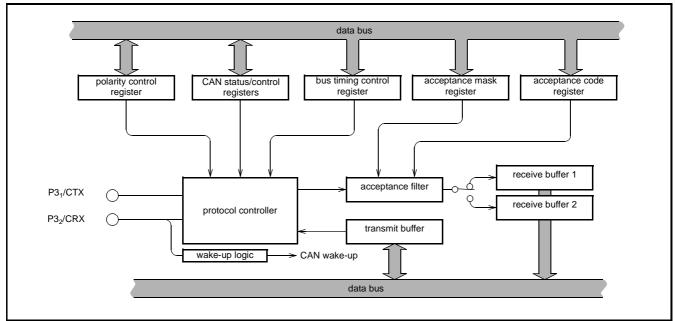


Fig. 31 Block diagram of CAN module



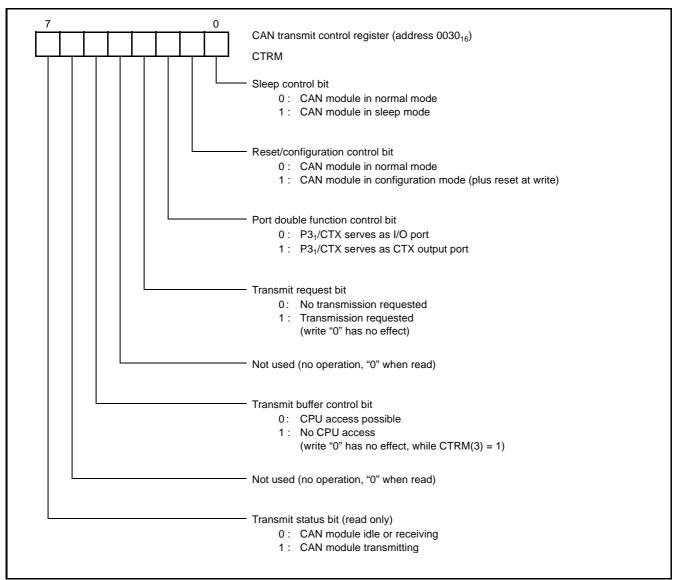


Fig. 32 Structure of CAN transmit control register

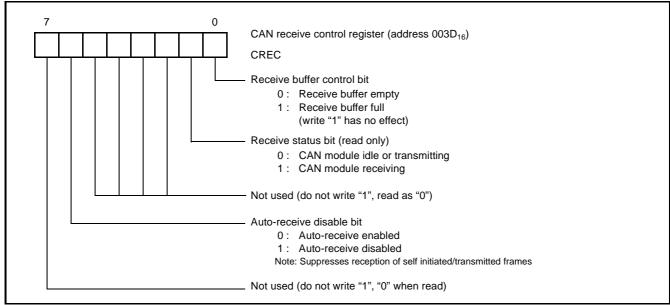


Fig. 33 Structure of CAN receive control register

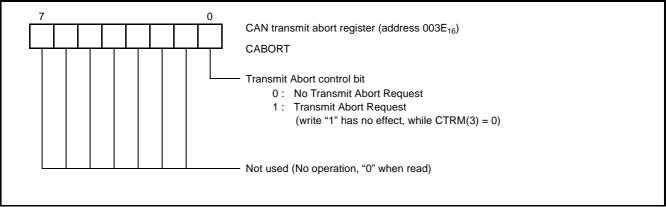


Fig. 34 Structure of CAN transmit abort register



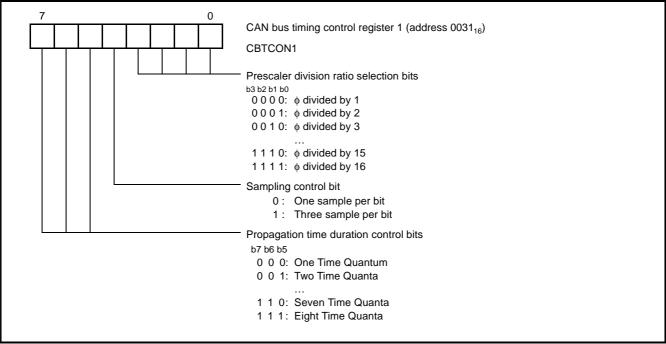


Fig. 35 Structure of CAN bus timing control register 1

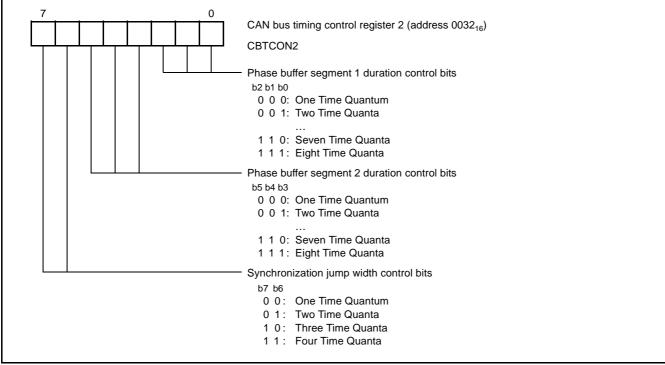


Fig. 36 Structure of CAN bus timing control register 2

	name	7							0	address
Acceptance code	CAC0	Not used	Not used	Not used	CSID <sub>10</sub>	CSID <sub>9</sub>	CSID <sub>8</sub>	CSID <sub>7</sub>	CSID <sub>6</sub>	0033 <sub>16</sub>
registers:	CAC1	CSID <sub>5</sub>	CSID <sub>4</sub>	CSID <sub>3</sub>	CSID <sub>2</sub>	CSID <sub>1</sub>	CSID <sub>0</sub>	Not used	Not used	0034 <sub>16</sub>
	CAC2	Not used	Not used	Not used	Not used	CEID <sub>17</sub>	CEID <sub>16</sub>	CEID <sub>15</sub>	CEID <sub>14</sub>	0035 <sub>16</sub>
	CAC3	CEID <sub>13</sub>	CEID <sub>12</sub>	CEID <sub>11</sub>	CEID <sub>10</sub>	CEID <sub>9</sub>	CEID <sub>8</sub>	CEID <sub>7</sub>	CEID <sub>6</sub>	0036 <sub>16</sub>
	CAC4	CEID <sub>5</sub>	CEID <sub>4</sub>	CEID <sub>3</sub>	CEID <sub>2</sub>	CEID <sub>1</sub>	CEID <sub>0</sub>	Not used	Not used	0037 <sub>16</sub>
		Select the	bit patterr	n of identifi	ers which	allows to p	ass acce	otance filte		
Acceptance mask registers:	CAM0		Not used	Not used	MSID <sub>10</sub>	MSID <sub>9</sub>	MSID <sub>8</sub>	MSID <sub>7</sub>	MSID <sub>6</sub>	0038 <sub>16</sub>
	CAM1	MSID <sub>5</sub>	MSID <sub>4</sub>	MSID <sub>3</sub>	MSID <sub>2</sub>	MSID <sub>1</sub>	MSID <sub>0</sub>	Not used	Not used	0039 <sub>16</sub>
	CAM2	Not used	Not used	Not used	Not used	MEID <sub>17</sub>	MEID <sub>16</sub>	MEID <sub>15</sub>	MEID <sub>14</sub>	003A <sub>16</sub>
	CAM3	MEID <sub>13</sub>	MEID <sub>12</sub>	MEID <sub>11</sub>	MEID <sub>10</sub>	MEID <sub>9</sub>	MEID <sub>8</sub>	MEID <sub>7</sub>	MEID <sub>6</sub>	003B <sub>16</sub>
	CAM4	MEID <sub>5</sub>	MEID <sub>4</sub>	MEID <sub>3</sub>	MEID <sub>2</sub>	MEID <sub>1</sub>	MEID <sub>0</sub>	Not used	Not used	003C <sub>16</sub>
		1 : Compa	dentifier bi are identifie : write to "(	er bit with	are) acceptance	e code reg	ister bit			

Fig. 37 Structure of CAN mask and code registers

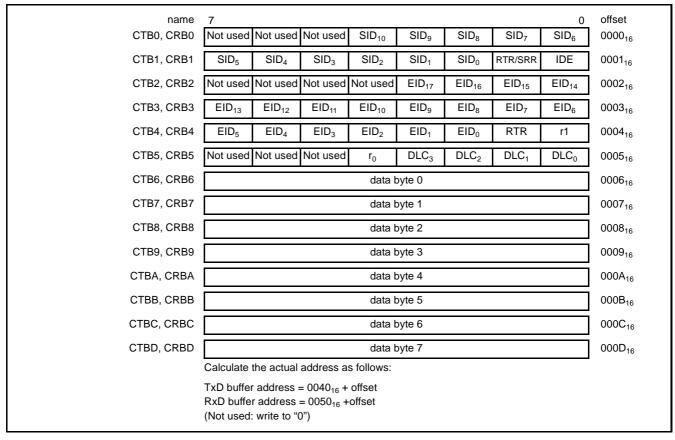


Fig. 38 Structure of CAN transmission and reception buffer registers

Note 1: All CAN related SFRs must not be written in "CAN sleep" mode.



# **A-D CONVERTER**

The A-D converter uses the successive approximation method with 8 bit resolution. The functional blocks of the A-D converter are described below. Refer to Block diagram of A-D converter.

## **Comparison Voltage Generator**

The comparison voltage generator divides the voltage between AV  $_{\rm SS}$  and V  $_{\rm REF}$  by 256, and outputs the divided voltage.

#### **Channel Selector**

The channel selector selects one of ports  $P0_0/AN_0$  to  $P0_7/AN_7$ , and inputs its voltage to the comparator.

# A-D conversion register AD

The A-D conversion register is a read-only register that stores the result of an A-D conversion. This register must not be read during an A-D conversion.

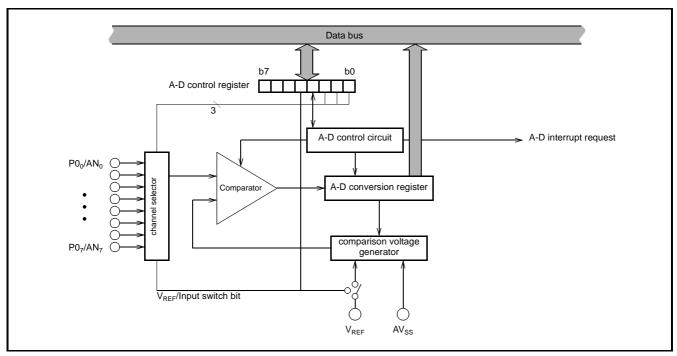


Fig. 39 Block diagram of A-D converter

# A-D control register (Structure of A-D control register)

The A-D control register controls the A-D conversion process. Bits 0 to 2 select a specific analog input pin. Bit 3 signals the completion of an A-D conversion. The value of this bit remains "0" during an A-

D conversion, and changes to "1" when an A-D conversion ends. Writing "0" to this bit starts the A-D conversion. Bit 4 is the  $V_{\text{REF}}\!/$  Input switch bit.



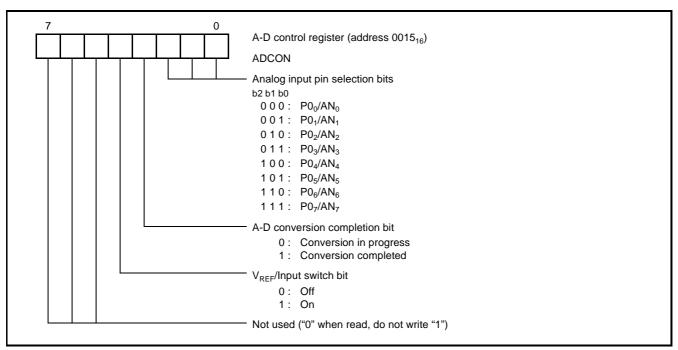


Fig. 40 Structure of A-D control register

# **A-D Converter Operation**

The comparator and control circuit reference an analog input voltage with the reference voltage, then stores the result in the A-D conversion register. When an A-D conversion is complete, the control circuit sets the A-D conversion completion bit and the A-D inter-

rupt request bit to "1". The result of A-D conversion can be obtained from the A-D conversion register, AD (address  $0014_{16}$ ).

Note that the comparator is linked to a capacitor, so set  $f(X_{\text{IN}})$  to 500 kHz or higher during A-D conversion.



## **WATCHDOG TIMER**

The watchdog timer consists of two separate counters: one 7-bit counter (WD<sub>H</sub>) and one 4-bit counter (WD<sub>L</sub>). Cascading both counters or using the high-order counter allows only to select the time-out from either 524288 or 32768 cycles of the internal clock  $\phi$ . Refer to Fig. 41 and Fig. 42. Both counters are addressed by the same watchdog timer register (WDT). When writing to this register, both counters will be set to the following default values:

- the high-order counter will be set to address 7F<sub>16</sub>
- the low-order counter will be set to address F<sub>16</sub>
   regardless of the data written to the WDT register. Reading the watchdog timer register will return the corresponding control bit status, not the counter contents.

Once the WDT register is written to, the watchdog timer starts counting down and the watchdog timer interrupt is enabled. Once it is running, the watchdog timer cannot be disabled or stopped except by reset. On a watchdog timer underflow, a non-maskable watchdog timer interrupt will be requested.

To prevent the system being stopped by STP instruction, this instruction can be disabled by the STP instruction disable bit of WDT register. Once the STP instruction is disabled, it cannot be enabled again except by RESET.

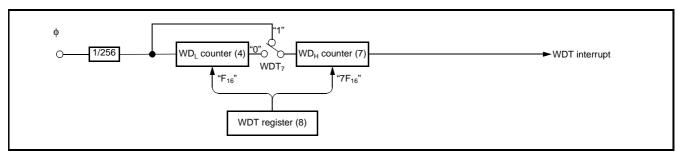


Fig. 41 Block diagram of watchdog timer

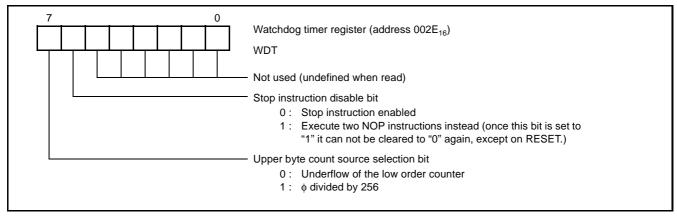


Fig. 42 Structure of watchdog timer register (φ is internal clock system)



# **RESET CIRCUIT**

The 7630 group is reset according to the sequence shown in Fig. 44. It starts program execution from the address formed by the contents of the addresses FFFB<sub>16</sub> and FFFA<sub>16</sub>, when the  $\overline{\text{RESET}}$  pin is held at "L" level for more than 2  $\mu$ s while the power supply voltage is

in the recommended operating condition and then returned to "H" level.

Refer to Fig. 43 for an example of the reset circuit.

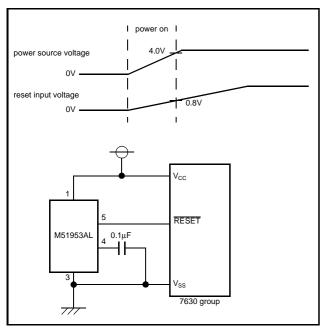


Fig. 43 Example of reset circuit

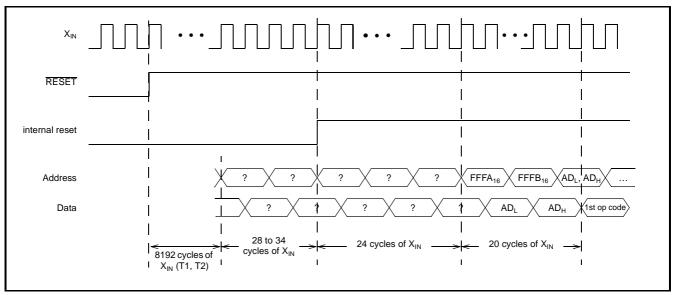


Fig. 44 Reset sequence



Register	Address	Register contents	Register	Address	Register contents
CPU mode reg.	0000 <sub>16</sub>	48 <sub>16</sub>	Timer XH	001B <sub>16</sub>	FF <sub>16</sub>
Interrupt request reg. A	0002 <sub>16</sub>	00 <sub>16</sub>	Timer YL	001C <sub>16</sub>	FF <sub>16</sub>
Interrupt request reg. B	0003 <sub>16</sub>	00 <sub>16</sub>	Timer YH	001D <sub>16</sub>	FF <sub>16</sub>
Interrupt request reg. C	0004 <sub>16</sub>	00 <sub>16</sub>	Timer X mode reg.	001E <sub>16</sub>	00 <sub>16</sub>
Interrupt control reg. A	0005 <sub>16</sub>	00 <sub>16</sub>	Timer Y mode reg.	001F <sub>16</sub>	00 <sub>16</sub>
Interrupt control reg. B	0006 <sub>16</sub>	00 <sub>16</sub>	UART mode reg.	002016	0010
Interrupt control reg. C	0007 <sub>16</sub>	00 <sub>16</sub>	UART control reg.	0022 <sub>16</sub>	00 <sub>16</sub>
Port P0 reg.	0008 <sub>16</sub>	00 <sub>16</sub>	UART status reg.	0023 <sub>16</sub>	07 <sub>10</sub>
Port P0 direction reg.	0009 <sub>16</sub>	00 <sub>16</sub>	Port P0 pull-up control reg.	0028 <sub>16</sub>	00 <sub>16</sub>
Port P1 reg.	000A <sub>16</sub>	00 <sub>16</sub>	Port P1 pull-up control reg.	0029 <sub>16</sub>	00 <sub>16</sub>
Port P1 direction reg.	000B <sub>16</sub>	00 <sub>16</sub>	Port P2 pull-up control reg.	002A <sub>16</sub>	00 <sub>16</sub>
Port P2 reg.	000C <sub>16</sub>	00 <sub>16</sub>	Port P3 pull-up control reg.	002B <sub>16</sub>	00 <sub>16</sub>
Port P2 direction reg.	000D <sub>16</sub>	00 <sub>16</sub>	Port P4 pull-up/down control reg.	002C <sub>16</sub>	00 <sub>16</sub>
Port P3 reg.	000E <sub>16</sub>	00 <sub>16</sub>	Interrupt polarity selection reg.	002D <sub>16</sub>	00 <sub>16</sub>
Port P3 direction reg.	000F <sub>16</sub>	00 <sub>16</sub>	Watchdog timer reg.	002E <sub>16</sub>	3F <sub>16</sub>
Port P4 reg.	0010 <sub>16</sub>	00 <sub>16</sub>	Polarity control reg.	002F <sub>16</sub>	00 <sub>16</sub>
Port P4 direction reg.	0011 <sub>16</sub>	00 <sub>16</sub>	CAN transmit control reg.	0030 <sub>16</sub>	02 <sub>16</sub>
Serial I/O control reg.	0013 <sub>16</sub>	00 <sub>16</sub>	CAN bus timing control reg. 1	0031 <sub>16</sub>	00 <sub>16</sub>
A-D control reg.	0015 <sub>16</sub>	08 <sub>16</sub>	CAN bus timing control reg. 2	0032 <sub>16</sub>	00 <sub>16</sub>
Timer 1	0016 <sub>16</sub>	FF <sub>16</sub>	CAN receive control reg.	003D <sub>16</sub>	00 <sub>16</sub>
Timer 2	0017 <sub>16</sub>	01 <sub>16</sub>	CAN transmit abort reg.	003E <sub>16</sub>	00 <sub>16</sub>
Timer 3	0018 <sub>16</sub>	FF <sub>16</sub>	Processor status reg.	(PS)	04 <sub>16</sub>
Timer 123 mode reg.	0019 <sub>16</sub>	40 <sub>16</sub>	Program counter (high-order byte)	(PCH)	contents of FFFB <sub>16</sub>
Timer XL	001A <sub>16</sub>	FF <sub>16</sub>	Program counter (low-order byte)	(PCL)	contents of FFFA <sub>16</sub>

Fig. 45 Internal status of microcomputer after reset

## **CLOCK GENERATING CIRCUIT**

The 7630 group is equipped with an internal clock generating circuit.

Please refer to Fig. 46 for a circuit example using a ceramic resonator or quartz crystal oscillator. For the capacitor values, refer to the manufacturers recommended parameters which depend on each oscillators characteristics. When using an external clock, input it to the  $X_{\text{IN}}$  pin and leave  $X_{\text{OUT}}$  open.

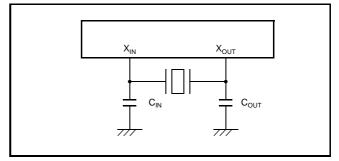


Fig. 46 Ceramic resonator circuit

clock oscillation becomes stable. When using reset, a fixed time-out will be generated allowing oscillation to stabilize.

#### Wait mode

The microcomputer enters the wait mode by executing the WIT instruction. The internal clock ø stops at "H" level while the oscillator keeps running.

Recovery from wait mode can be done in the same way as from stop mode. However, the time-out period mentioned above is not required to return from wait-mode, thus no such time-out mechanism has been implemented.

Note: Set the interrupt enable bit of the interrupt source to be used to return from stop or wait mode to "1" before executing STP or WIT instruction.

## **Oscillation Control**

The 7630 group has two low power modes: the stop and the wait mode.

#### Stop mode

The microcomputer enters the stop mode by executing the STP instruction. The oscillator stops with the internal clock  $\phi$  at "H" level. Timers 1 and 2 will be cascaded and initialized by their reload latches contents. The count source for timer 1 will be set to  $f(X_{\text{IN}})/16$ .

Oscillation is restarted if an external interrupt is accepted or at reset. When using an external interrupt, the internal clock  $\phi$  remains at "H" level until timer 2 underflows allowing a time-out until the

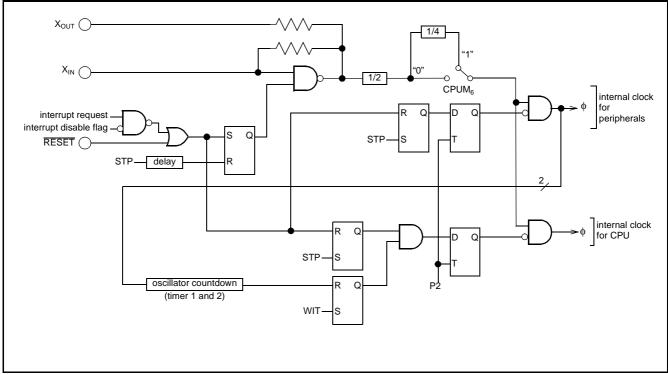


Fig. 47 Block diagram of clock generating circuit



# **DATA REQUIRED FOR MASK ORDERS**

The following are necessary when ordering a mask ROM production:

- 1 Mask ROM Order Confirmation Form
- 2 Mark Specification Form
- 3 Contents of Mask ROM, in EPROM form (three identical copies)

# **PROM PROGRAMMING METHOD**

The built-in PROM of the blank One Time PROM version and built-in EPROM version can be read or programmed with a general purpose PROM programmer using a special programming adapter. Set the address of PROM programmer to the user ROM area.

For the programming adapter type name, please refer to the following table:

Table 6: Programming adapter name

MCU type	Package	Programming adapter type
One Time PROM	44P6N-A	PCA7430
EPROM	80D0	PCA7431

The PROM of the blank One Time PROM version is not tested or screened in the assembly process and following processes. To ensure proper operation after programming, the procedure shown in Fig. 48 is recommended to verify programming.

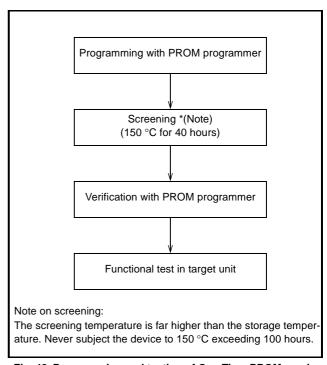


Fig. 48 Programming and testing of One Time PROM version



## **Table 7: ABSOLUTE MAXIMUM RATINGS**

Symbol	Pa	rameter	Conditions	Ratings	Unit
V <sub>CC</sub>	Power source voltage			-0.3 to 7.0	V
V <sub>I</sub>	Input voltage	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET, X <sub>IN</sub>	All voltages with respect to V <sub>SS</sub> and output transistors are "off".	-0.3 to V <sub>CC</sub> + 0.3	V
V <sub>O</sub>	Output voltage P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>2</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , X <sub>OUT</sub>		and output transisions are oil .	-0.3 to V <sub>CC</sub> + 0.3	V
$P_d$	Power dissipation		Ta = 25 °C	500	mW
T <sub>opr</sub>	Operating temperature			-40 to 85	°C
T <sub>stg</sub>	Storage temperature			-60 to 150	°C

# **Table 8: RECOMMENDED OPERATING CONDITIONS**

(V<sub>CC</sub> = 4.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = 0 V,  $T_a$  = -40 to 85 °C unless otherwise noted)

Symbol	Parameter			Unit		
Symbol	га	Parameter			max.	Unit
V <sub>CC</sub>	Power source voltage		4.0	5.0	5.5	V
V <sub>SS</sub>	- Fower source voitage			0		V
V <sub>IH</sub>	"H" Input voltage	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET, X <sub>IN</sub>	0.8 · V <sub>CC</sub>		V <sub>cc</sub>	V
V <sub>IL</sub>	"L" Input voltage	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET, X <sub>IN</sub>	0		0.2 · V <sub>CC</sub>	V
∑ I <sub>OH</sub> (peak)	"H" sum peak output current	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>2</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>			-80	mA
$\sum$ I <sub>OH</sub> (avg)	"H" sum average output current				-40	mA
$\sum$ I <sub>OL</sub> (peak)	"L" sum peak output current				80	mA
$\sum$ I <sub>OL</sub> (avg)	"L" sum average output current		1		40	mA
I <sub>OH</sub> (peak)	"H" peak output current				-10	mA
I <sub>OH</sub> (avg)	"H" average output current				<b>-</b> 5	mA
I <sub>OL</sub> (peak)	"L" peak output current				10	mA
I <sub>OL</sub> (avg)	"L" average output current				5	mA
I <sub>IO</sub>	input current at overvoltage condition (V <sub>I</sub> > V <sub>CC</sub> )	P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>			1	mA
$\sum$ I <sub>IO</sub>	total input current at overvoltage condition (V <sub>I</sub> > V <sub>CC</sub> )	P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>			16	mA
f(CNTR)	Timer input frequency	P1 <sub>4</sub> /CNTR <sub>0</sub> , P1 <sub>5</sub> /CNTR <sub>1</sub> (except bi-phase counter mode)			f(X <sub>IN</sub> )/16	MHz
	(based on 50 % duty)	P1 <sub>3</sub> /TX <sub>0</sub> , P1 <sub>4</sub> /CNTR <sub>0</sub> (bi-phase counter mode)			f(X <sub>IN</sub> )/32	MHz
f(X <sub>IN</sub> )	Clock input oscillation frequency				10	MHz



**Table 9: ELECTRICAL CHARACTERISTICS** 

(V<sub>CC</sub> = 4.0 to 5.5 V, V<sub>SS</sub> = AV<sub>SS</sub> = 0 V, T<sub>a</sub> = - 40 to 85 °C unless otherwise noted)

Courab al	De	Parameter			Unit			
Symbol	Parameter		Test conditions	min.	typ.	max.	Unit	
V <sub>OH</sub>	"H" output voltage	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>2</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>	I <sub>OH</sub> = -5 mA	0.8 · V <sub>CC</sub>			V	
V <sub>OL</sub>	"L" output voltage	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>2</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>	I <sub>OL</sub> = 5 mA			2.0	V	
$V_{T+} - V_{T-}$	Hysteresis	P1 <sub>1</sub> /INT <sub>0</sub> , P1 <sub>2</sub> /INT <sub>1</sub> , P1 <sub>3</sub> /TX <sub>0</sub> , P1 <sub>4</sub> /CNTR <sub>0</sub> , P1 <sub>5</sub> /CNTR <sub>1</sub> , P2 <sub>0</sub> /S <sub>IN</sub> , P2 <sub>2</sub> /S <sub>CLK</sub> , P2 <sub>6</sub> /U <sub>RTS</sub> , P2 <sub>7</sub> /U <sub>CTS</sub> , P3 <sub>2</sub> /CRX, RESET			0.5		V	
I <sub>IH</sub>	"H" input current	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET	V <sub>I</sub> = V <sub>CC</sub>			5	μА	
I <sub>IH</sub>	"H" input current	X <sub>IN</sub>	$V_I = V_{CC}$		4		μΑ	
I <sub>IL</sub>	"L" input current	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET	V <sub>I</sub> = V <sub>SS</sub>			-5	μА	
I <sub>IL</sub>	"L" input current	X <sub>IN</sub>	$V_I = V_{SS}$		-4		μΑ	
I <sub>IH</sub>	"H" input current	P3 <sub>2</sub> , P4 <sub>0</sub> —P4 <sub>7</sub>	$V_1 = V_{CC}$ Pull-Down = 'On'	20		200	μΑ	
I <sub>IL</sub>	"L" input current	P0 <sub>0</sub> —P0 <sub>7</sub> , P1 <sub>1</sub> —P1 <sub>7</sub> , P2 <sub>0</sub> —P2 <sub>7</sub> , P3 <sub>0</sub> —P3 <sub>4</sub> , P4 <sub>0</sub> —P4 <sub>7</sub> , RESET	V <sub>I</sub> = V <sub>SS</sub> Pull-Up = 'On'	-200		-20	μА	
V <sub>RAM</sub>	RAM hold voltage		When clock stopped	2.0			V	



Cumbal	Parameter	Test conditions		Limits			
Symbol	Faidilletei	rest conditions	min.	typ.	max.	Unit	
		high speed mode, $f(X_{ N}) = 8MHz$ , $V_{CC} = 5V$ , output transistors off, CAN module running, ADC running		11.0	18.0	mA	
		high speed mode, f(X <sub>IN</sub> ) = 8MHz, V <sub>CC</sub> = 5V, output transistors off, CAN module stopped, ADC running		9.0	16.0	mA	
I <sub>cc</sub>	Power source current	middle speed mode, $f(X_{ N}) = 8MHz, V_{CC} = 5V,$ output transistors off, CAN module running, ADC running		6.0	11.0	mA	
		middle speed mode, wait mode, $f(X_{IN}) = 8MHz$ , $V_{CC} = 5V$ , output transistors off, CAN module stopped, ADC stopped		2.0		mA	
		stop mode, $f(X_{IN}) = 0MHz$ , $V_{CC} = 5V$ , $T_a = 25$ °C		0.1	1.0	μА	
		stop mode, $f(X_{IN}) = 0MHz$ , $V_{CC} = 5V$ , $T_a = 85^{\circ}C$			10.0	μА	

## Table 10: A-D converter characteristics

( $V_{CC}$  = 4.0 to 5.5 V,  $V_{SS}$  = AV<sub>SS</sub> = 0 V,  $T_a$  = -40 to 85 °C, unless otherwise noted)

Parameter	Test conditions		Unit			
i diametei	rest conditions	min.	typ.	max.	Offic	
Resolution				8	Bit	
Absolute accuracy			±1.0	±2.5	LSB	
Conversion time	high-speed mode	106		108	$t_{C}(X_{IN})$	
Conversion time	middle-speed mode	424		432	$t_C(X_{IN})$	
Reference input voltage		2.0		V <sub>CC</sub>	V	
Reference input current	$V_{CC} = V_{REF} = 5.12 \text{ V}$		150	200	μΑ	
Ladder resistor value			35		kΩ	
Analog input current	$V_I = V_{SS}$ to $V_{CC}$		0.5	5.0	μΑ	
	Absolute accuracy  Conversion time  Reference input voltage  Reference input current  Ladder resistor value	Resolution  Absolute accuracy  Conversion time  Reference input voltage  Reference input current  Ladder resistor value  Resolution  high-speed mode  middle-speed mode  V <sub>CC</sub> = V <sub>REF</sub> = 5.12 V	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	Resolution         min.         typ.           Absolute accuracy         ±1.0           Conversion time         high-speed mode middle-speed mode         106 middle-speed mode           Reference input voltage         2.0           Reference input current         V <sub>CC</sub> = V <sub>REF</sub> = 5.12 V         150           Ladder resistor value         35	Parameter         Test conditions           min.         typ.         max.           Resolution         8           Absolute accuracy         ±1.0         ±2.5           Conversion time         high-speed mode         106         108           middle-speed mode         424         432           Reference input voltage         2.0         V <sub>CC</sub> Reference input current         V <sub>CC</sub> = V <sub>REF</sub> = 5.12 V         150         200           Ladder resistor value         35	



**Table 11: Timing requirements** 

(V<sub>CC</sub>=4.0 to 5.5 V, V<sub>SS</sub>=AV<sub>SS</sub>=0 V, T<sub>a</sub>=-40 to 85  $^{\circ}\text{C}$  unless otherwise noted)

Cumhal	Dorometer		Lloit		
Symbol	Parameter	min.	max.	— Unit	
t <sub>W</sub> (RESET)	Reset input "L" pulse width	2			μs
t <sub>C</sub> (X <sub>IN</sub> )	External clock input cycle time	100			ns
t <sub>WH</sub> (X <sub>IN</sub> )	External clock input "H" pulse width	37			ns
t <sub>WL</sub> (X <sub>IN</sub> )	External clock input "L" pulse width	37			ns
t <sub>C</sub> (CNTR)	CNTR <sub>0</sub> , CNTR <sub>1</sub> input cycle time (except bi-phase counter mode)	1600			ns
	CNTR <sub>0</sub> input cycle time (bi-phase counter mode)	2000			ns
t <sub>WH</sub> (CNTR)	CNTR <sub>0</sub> , CNTR <sub>1</sub> input "H" pulse width (except bi-phase counter mode)	800			ns
	CNTR <sub>0</sub> input "H" pulse width (bi-phase counter mode)	1000			ns
t <sub>WL</sub> (CNTR)	CNTR <sub>0</sub> , CNTR <sub>1</sub> input "L" pulse width (except bi-phase counter mode)	800			ns
	CNTR <sub>0</sub> input "L" pulse width (bi-phase counter mode)	1000			ns
t <sub>L</sub> (CNTR <sub>0</sub> -TX <sub>0</sub> )	Lag of CNTR <sub>0</sub> and TX <sub>0</sub> input edges (bi-phase counter mode)	500			ns
t <sub>C</sub> (TX <sub>0</sub> )	TX <sub>0</sub> input cycle time (bi-phase counter mode)	3200			ns
t <sub>WH</sub> (TX <sub>0</sub> )	TX <sub>0</sub> input "H" pulse width (bi-phase counter mode)	1600			ns
t <sub>WL</sub> (TX <sub>0</sub> )	TX <sub>0</sub> input "L" pulse width (bi-phase counter mode)	1600			ns
t <sub>WH</sub> (INT)	INT <sub>0</sub> , INT <sub>1</sub> input "H" pulse width	460			ns
t <sub>WL</sub> (INT)	INT <sub>0</sub> , INT <sub>1</sub> input "L" pulse width	460			ns
t <sub>C</sub> (S <sub>CLK</sub> )	Serial I/O clock input cycle time	$8 \cdot t_{C}(X_{IN})$			ns
t <sub>WH</sub> (S <sub>CLK</sub> )	Serial I/O clock input "H" pulse width	$4 \cdot t_{C}(X_{IN})$			ns
t <sub>WL</sub> (S <sub>CLK</sub> )	Serial I/O clock input "L" pulse width	$4 \cdot t_{C}(X_{IN})$			ns
t <sub>SU</sub> (S <sub>IN</sub> -S <sub>CLK</sub> )	Serial I/O input setup time	200			ns
t <sub>H</sub> (S <sub>CLK</sub> -S <sub>IN</sub> )	Serial I/O input hold time	150			ns



**Table 12: Switching characteristics** 

 $(V_{CC} = 4.0 \text{ to } 5.5 \text{ V}, V_{SS} = \text{AV}_{SS} = 0 \text{ V}, \quad T_a = -40 \text{ to } 85 \,^{\circ}\text{C}, \quad \text{unless otherwise noted})$ 

Symbol	Parameter	Limits			
Symbol	Faranteter	min.	typ.	max.	Unit
t <sub>WH</sub> (S <sub>CLK</sub> )	Serial I/O clock output "H" pulse width	$0.5 \cdot t_{C}(S_{CLK}) - 50$			ns
t <sub>WL</sub> (S <sub>CLK</sub> )	Serial I/O clock output "L" pulse width	$0.5 \cdot t_{\rm C}(S_{\rm CLK}) - 50$			ns
$t_D(S_{CLK}-S_{OUT})$	Serial I/O output delay time			50	ns
$t_V(S_{CLK}-S_{OUT})$	Serial I/O output valid time	0		50	ns
$t_R(S_{CLK})$	Serial I/O clock output rise time			50	ns
t <sub>R</sub> (CMOS)	CMOS output rise time		10	50	ns
t <sub>F</sub> (CMOS)	CMOS output fall time		10	50	ns

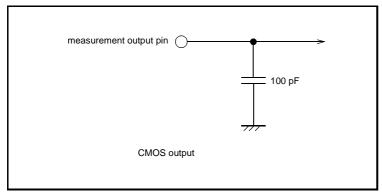


Fig. 49 Circuit for measuring output switching characteristics



# **TIMING DIAGRAM**

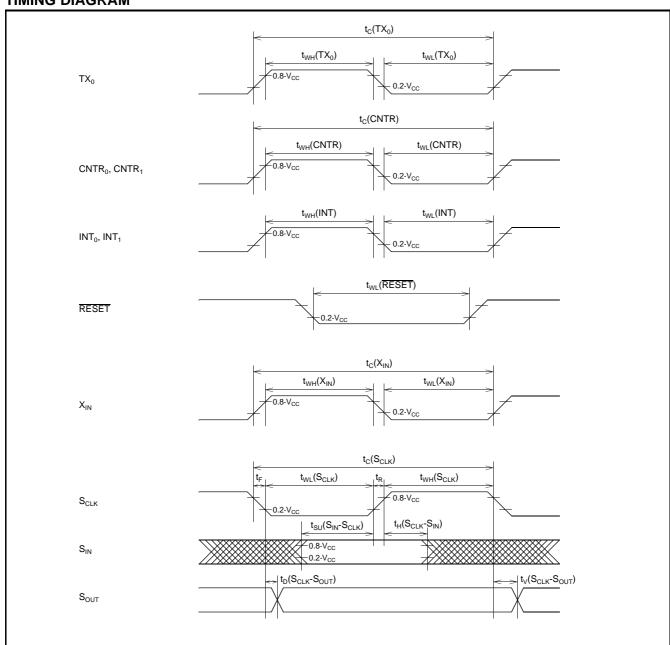


Fig. 50 Timing diagram

1

REVISION	DATE	Pa	age	MODIFICATIONS
		New	Old	
1.1	10. 98			"CAN controller" is replaced by "CAN module" in whole document.
		11	11	Schematics (8) and (11) are corrected.
		18	18	Replaced: "PUPD <sub>j</sub> " with "PUP4 <sub>j</sub> "
		26	26	Replaced: "UT <sub>X</sub> D" with "SOUT"
				Replaced: "UR <sub>X</sub> D" with "SIN"
		38	38	Replaced: "FFFB <sub>H</sub> " with "FFFB <sub>16</sub> "
				Replaced: "FFFA <sub>H</sub> " with "FFFA <sub>16</sub> "
		41		Replaced: "44P6N" with "44P6N-A)
(1.2)	13.01.99	43	43	Values changed: Iih(35, 113) to (20, 200) and Iil(-122, -70) to
				(-200, -20); typical values are removed.
		10	10	Schematic (1) is modified.
		35	35	Fig. 39 is modified.